Tektronix[®]

TekExpress® SFP+ QSFP+ Tx Compliance and Debug Solution Software Application Help

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- In North America, call 1-800-833-9200.
- Worldwide, visit to www.tek.com find contacts in your area.

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Welcome

TekExpress is the Tektronix Test Automation Framework, developed to support your current and future test automation needs. TekExpress uses a highly modular architecture that lets you deploy automated test solutions for various standards in a relatively short time.



Note: The skew between Data+ and Data- in the signal path from the DUT to the oscilloscope will be computed and compensated before running the measurements.



Key Features

- Allows conformance testing to the latest Compliance Test Specification (CTS)
- Reliable Testing:
 - · Conformance to SFP+ and QSFP+ interconnect module electrical testing ensures reliable results
 - SFP+ QSFP+ Tx is SFP+ and QSFP+ compliance software
 - Enables execution of the physical-layer (PHY), electrical tests, and SFP+/QSFP+ based electrical measurements
- Automated testing:
 - · Minimizes user intervention when conducting time-consuming testing
 - Reduces the time required to conduct testing
- Selective testing:
 - · Performs fully-automated testing for transmitter measurements
 - · Allows you to select individual tests or test groups in the tree-structure
 - · Avoids repeated testing through accurate and reliable results from a single run
- Quick testing:
 - · One-button selection of multiple tests ensures faster testing
 - Test margins and statistical information aid analysis to find answers quickly

- One-button .mht report saves time
- Complete Solution:
 - Wide range of tests for SFP+/QSFP+ Host devices and SFP+/QSFP+ Module devices enables complete validation
 - Complete compliance solution with an elaborate test fixture and signal sources support for SMA cable-based solution provides cost-effective way to perform compliance testing
 - User defined mode supports PRBS7, PRBS11, PRBS15, PRBS20 and PRBS23 in addition to patterns supported in Compliance mode including PRBS9, PRBS31 and 8180
- Customize the setup:
 - Modify the test setup according to the DUT configuration.
 - Run test measurements with different record lengths.
 - Run test measurements with more than one signal.
- Detailed test reporting:
 - Provides a Pass/Fail summary table
 - Provides margin details on each test
 - · Provides a consolidated report for all tests
 - · Provides additional information such as skew and signal type selected for each measurement

Getting help and support

Product documents

Use the product documents for more information on the application functions, understand the theory of operation, how to remotely program or operate the application, and do other tasks.

Table 1: TekExpress Application documents

To learn about	Use this document
How to use the application	TekExpress SFP+ QSFP+ Help
How to remotely control the instrument	PDF version of this document can be downloaded from www.tek.com/downloads
	Compiled HTML (CHM) version is integrated with the application. Press F1 key from the keyboard to start the help.
	Tektronix Part Number: 077-xxxx-xx

Conventions

This application help uses the following conventions:

- The term "Application," and "Software" refers to the TekExpress SFP+ QSFP+ application.
- The term "DUT" is an abbreviation for Device Under Test.
- The term "select" is a generic term that applies to the two methods of choosing a screen item (button control, list item): using a mouse or using the touch screen.
- A Note identifies important information.

Table 2: Icons used in the help

Icon	Description
Version and Versio	This icon identifies important information
\wedge	This icon identifies conditions or practices that could result in loss of data.
_	This icon identifies additional information that will help you use the application more efficiently.

Technical support

Tektronix values your feedback on our products. To help us serve you better, please send us your suggestions, ideas, or comments on your application or oscilloscope. Contact Tektronix through mail, telephone, or the Web site. See *Contacting Tektronix* at the front of this document for contact information.

When you contact Tektronix Technical Support, please include the following information (be as specific as possible):

General information

- All instrument model numbers
- · Hardware options, if any
- Modules used
- · Your name, company, mailing address, phone number, FAX number
- · Please indicate if you would like to be contacted by Tektronix about your suggestion or comments.

Application specific information

- Software version number
- · Description of the problem such that technical support can duplicate the problem
- · If possible, save the setup files for all the instruments used and the application
- If possible, save the TekExpress setup files, log.xml, *.TekX (session files and folders), and status messages text file

Getting started

Hardware requirements

Minimum system requirements

The following table describes the minimum system requirements for the TekExpress SFP+ QSFP+ application.

Instruments	Description
Processor	Same as the oscilloscope
Operating System	Same as the oscilloscope (Windows 7, 64-bit only)
Memory	Same as the oscilloscope
Hard Disk	Same as the oscilloscope
Display	Same as the oscilloscope ¹
Firmware	TekScope 10.3.3 for non-SX series digital oscilloscopes
	TekScope 10.3.0 for SX series digital oscilloscopes
Software	 DPOJET, Jitter and Eye Diagram Analysis Tool, version 10.0.0.35 or later (64-bit) MathWorks MATLAB Runtime 8.0² (Windows 7) IronPython 2.7.3 PyVisa 1.0.0.25 Microsoft .NET 4.0 Framework Microsoft Internet Explorer 6.0 SP1 or later Microsoft Photo Editor 3.0 or equivalent software for viewing image files Adobe Reader 7.0 or equivalent software for viewing portable document format (PDF) files
Other Devices	 Microsoft compatible mouse or compatible pointing device Four USB ports (two USB ports minimum) PCI-GPIB or equivalent interface for instrument connectivity ³

Table 3: Minimum system requirements

Supported instruments

The TekExpress SFP+ QSFP+ Tx application runs on the following Tektronix oscilloscopes:

- DPO/DSA/MSO71604C and DPO/DSA/MSO72004C Series Digital Oscilloscopes
- DPO/DSA72504D and DPO/DSA73304D Series Digital Oscilloscopes
- DPO/MSO71604DX, DPO/MSO72004DX, DPO/MSO72304DX, DPO/MSO72504DX, and DPO/MSO73304DX Series Digital Oscilloscopes

¹ If TekExpress is running on an instrument having a video resolution lower than 800x600 (for example, a sampling oscilloscope), it is recommended that you connect a secondary monitor, which must be enabled before launching the application.

² MatLab Runtime Compiler is required for performing the Host Output TWDPc test. This test is purchase option SFP-WDP.

³ If TekExpress is installed on a Tektronix oscilloscope, TekExpress will use the virtual GPIB port for communicating with oscilloscope applications. If external GPIB communication devices such as USB-GPIB-HS or equivalent are used for instrument connectivity, make sure that the Talker Listener utility is enabled in the GPIB menu of the DPO/DSA oscilloscope. For ease of use, connect to an external (secondary) monitor.

DPO70000SX, DPO72004SX, and DPO72504SX Series Digital Oscilloscopes

See also

Minimum system requirements on page 13

Software requirements

Downloading and installing the software

Complete the following steps to download and install the latest TekExpress SFP+ QSFP+ application.

- 1. Go to www.tek.com.
- Click Downloads. In the Downloads menu, select DOWNLOAD TYPE as Software and enter the application name in the MODEL OR KEYWORD field and click SEARCH.



- 3. Select the latest version of software and follow the instructions to download the software. Copy the executable file into the oscilloscope.
- 4. Double-click the executable and follow the on-screen instructions.

The software is installed at C:\Program Files\Tektronix\TekExpress\TekExpress SFP+ QSFP+.

5. Select Application > TekExpress SFP+ QSFP+ from the Oscilloscope menu, to open the application.

Activate the license

Activate the license using the **Option Installation** wizard in the TekScope application:

- 1. In the TekScope application menu bar, click Utilities > Option Installation. The TekScope Option Installation wizard opens.
- 2. Push the F1 key on the oscilloscope keyboard to open the Option Installation help topic.
- 3. Follow the directions in the help topic to activate the license.

View software version and license key details

To view version information of the application, click Options > About TekExpress.



Setting up the test environment

Setting up tests

Set up tests using the tabs in the Setup panel. Settings in the DUT tab use a top-down, left-to-right logic flow, so that any parameter that affects or acts as a filter for other parameters appears either above or to the left of the affected parameters.

Test options: standards, views, and modes

Test options include two standards, QSFP+ Tx and SFP+ Tx (selected in the DUT tab of the Setup panel), two views, Compliance and Advanced (selected in the DUT tab of the Setup panel), and two modes, Compliance and User Defined (selected in the configuration settings of the Setup panel).

The selected standard determines which measurement standard will be used. The selected view determines where the test configuration settings are displayed. The selected mode determines whether you can change test configuration settings to include those that are noncompliant.

Compliance View selected with Compliance Mode

View configuration options in the Test Selection tab of the Setup panel. Tests will run automatically with little or no user intervention. You will not be able to change test parameters to anything that deviates from the compliance standards. The only test configuration parameters that you can change in this mode are the Global Settings.

Compliance View selected with User-Defined Mode

View configuration options in the Test Selection tab of the Setup panel. Tests will run automatically but you will be able to change the parameters before starting the tests.

Advanced View selected with Compliance Mode

View configuration options in the Configuration tab of the Setup panel. Tests will run automatically with little or no user intervention. You will not be able to change test parameters to anything that deviates from the compliance standards. The only configuration parameters that you can change in this mode are the Global Settings.

· Advanced View selected with User-Defined Mode

View configuration options in the Configuration tab of the Setup panel. Tests will run automatically but you will be able to change test parameters before starting the tests.

Supported tests

The application supports the following tests, grouped by profile.

Host Profile Tests

- SFF-8431 Table 11 Output Electrical Specifications at B:
 - Single Ended Output Voltage Range
 - Output AC Common Mode voltage (RMS)
- SFF-8431 Table 12 Jitter and Eye Mask Specifications at B:
 - Crosstalk Source Rise/Fall Time (20%–80%)
 - Crosstalk Source Amplitude (p-p Differential)
 - Signal Rise/Fall Time (20%–80%)
 - Total Jitter
 - Data Dependent Jitter
 - Data Dependent Pulse Width Shrinkage
 - Uncorrelated Jitter
 - Transmitter Qsq

- Eye Mask Hit Ratio
- SFF-8431 Table 33 Output Specifications at B for Cu:



Note: The group SFF-8431 Table 33 Output Specifications at B for Cu is associated with the 10GSFP+ Cu Direct Attach Cable device profile (the check box for this profile is located on the DUT tab of the Setup panel). This group of tests is available only when this check box is selected.

- Voltage Modulation Amplitude (p-p)
- Transmitter Qsq (for Cu)
- Output AC Common Mode voltage (RMS) (for Cu)
- Host Output TWDPc

Note: An evaluation version of the Host Output TWDPc test is included in the SFP+ QSFP+ Tx installation. You are allowed 10 free trials of this test. Each time you run the test, regardless of how often you open the application, one of the free trials is used. To use this test after the evaluation period, purchase the SFP-WDP option license key.

Module Profile Tests

- SFF-8431 Table 16 Transmitter Input Electrical Specifications at B:
 - AC Common-Mode Voltage Tolerance
 - Single-Ended Input Voltage Tolerance
- SFF-8431 Table 17 Transmitter Input Tolerance Signal Calibrated at B:
 - Crosstalk Source Rise/Fall Time (20%-80%)
 - Crosstalk Source Amplitude (p-p Differential)
 - Output AC Common-Mode Voltage (RMS)
 - Total Jitter
 - Data Dependent Jitter
 - Data Dependent Pulse Width Shrinkage
 - Uncorrelated Jitter
 - Eye Mask Hit Ratio
- Additional Supported Measurements for QSFP+ only
 - Total Jitter @ J2
 - Total Jitter @ J9

Instrument connection setup

To run tests, you need the following instrument (for details, see Minimum System Requirements):

- A supported Tektronix oscilloscope.
- The device under test
- SFP+ or QSFP+ fixtures

Table 4: SFP+ and QSFP+ fixtures

Tektronix nomenclature	Description
TF-SFP-TPA-HCB-P	SFP+ Host Compliance Board Plug
TF-SFP-TPA-MCB-R	SFP+ Module Compliance Board Receptacle
TF-SF-TPA-PR	SFP+ Host Compliance Board Plug and Module Compliance Board Receptacle
Table continued	

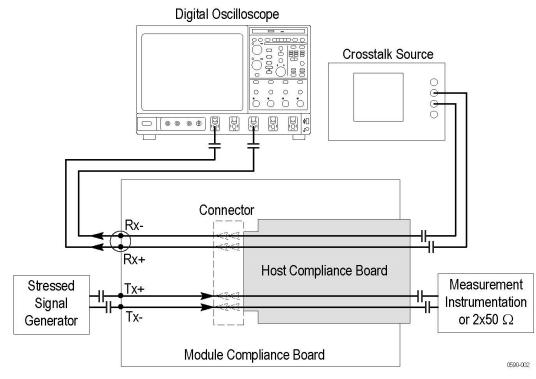
TekExpress® SFP+ QSFP+ Tx Compliance and Debug Solution Software Application Help

Tektronix nomenclature	Description
TF-SFP-TPAHCB-PK	SFP+ Host Compliance Board Plug Kit with DC Blocks and Termination
TF-SFP-TPAMCB-RK	SFP+ Module Compliance Board Receptacle Kit with DC Block and Termination
TF-SFP-TPA-PRK	SFP+ Host Module Compliance Board and Module Compliance Board with DC Blocks and Termination
TF-QSFP-TPAHCB-P	QSFP+ Host Compliance Plug
TF-QSFP-TPAMCB-R	QSFP+ Module Compliance Board Receptacle
TF-QSFP-TPA-PR	QSFP+ Host Compliance Board Plug and Module Compliance Board Receptacle
TF-DC-BLOCK-KIT	DC Block Kit

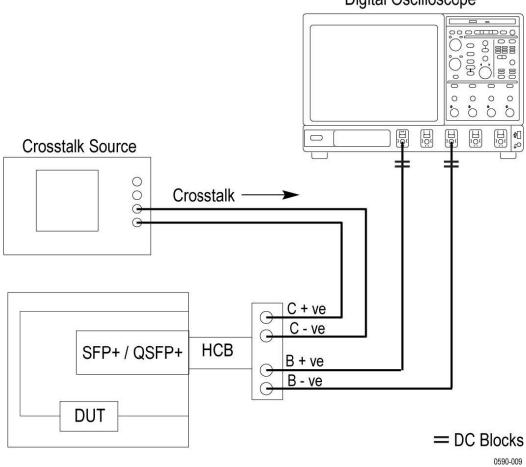
Equipment connections can vary by Device Profile (Host and Module) and by individual test. Refer to the following connection diagrams when setting up equipment for testing.

Connection setup for host tests

Table 12 Crosstalk Source tests

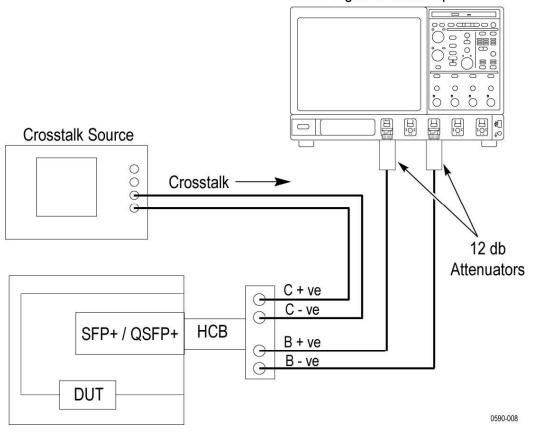


All other Host tests



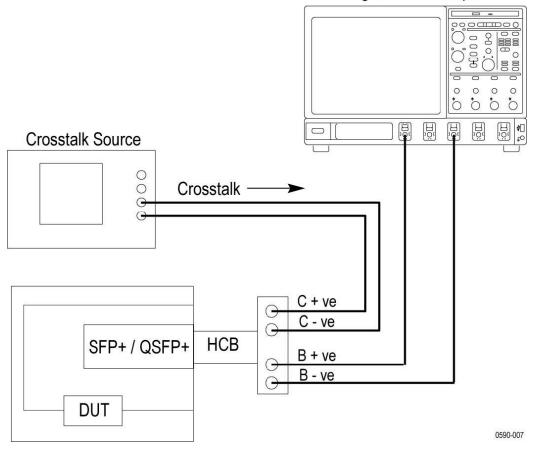
Digital Oscilloscope

Test setup for all measurements other than single-ended output voltage range



Digital Oscilloscope

Test setup for single ended output voltage range measurement on DPO/DSA70000D series oscilloscopes

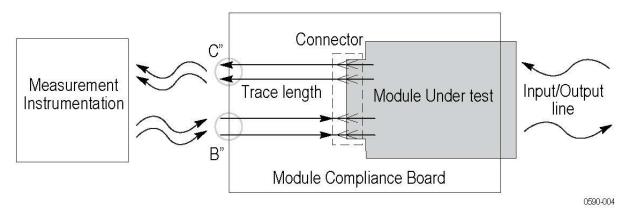


Digital Oscilloscope

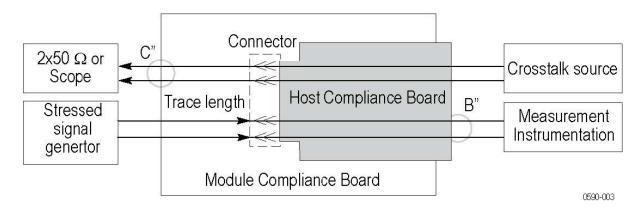
Test setup for single ended output voltage range measurement on all oscilloscopes other than DPO/DSA70000D series oscilloscopes

Connection setup for module tests

Single-Ended Input Voltage Tolerance Test



All other Module tests



Test setup overview

A test setup includes configuration parameters and report options. Use the options in the *Setup panel* and *Reports panel* to select and configure tests.

- 1. Select the DUT parameters
- 2. Select one or more tests
- 3. Select acquisitions
- **4.** Configure test parameters
- 5. Select test notification preferences
- 6. Select report options

Search instruments connected to the application

Use the TekExpress Instrument Control Settings dialog box to search the instruments (resources) connected to the application. The application uses TekVISA to discover the connected instruments.



Note: The instruments required for the test setup must be connected and detected by the application, before running the test.

To refresh the list of connected instruments:

- 1. Select Options > Instrument Control Settings.
- 2. In the Search Criteria section of the Instrument Control Settings dialog box, select the connection types of the instruments to search. Instrument search is based on the VISA layer, but different connections determine the resource type, such as LAN, GPIB, and USB. For example, if you choose LAN, the search will include all the instruments supported by the TekExpress that are communicating over the LAN.
- 3. Click Refresh. The TekExpress application searches for the connected instruments.

Search status of the instruments connected to LAN



4. When the search is complete, a dialog box lists the instrument-related details based on the search criteria. For example, for the Search Criteria as GPIB, the application displays all the GPIB instruments connected to the application.

TekExpress Instrument Control Settings window.

	GPIB 📄 Serial	Non - VISA Reso	ources	
	USB 🔲 VXI		Refresh	TekVISA 300 s Timeout
Retrieved Instru Connection	Resource	Serial No	Options	Resource Addr
VISA-GPIB	DPO73304SX	QU000053	10XL,PTH1,ASM,E	GPIB8::1::INSTR

The details of the instruments are displayed in the Retrieved Instruments table. The time and date of instrument refresh is displayed in the Last Updated field.

Running tests

After selecting and configuring tests, review the *pre-run checklist* and then click **Start** to perform the tests. The application acquires and analyzes the data, then displays a report when the tests are finished.

While the tests are running, other applications may display windows in the background. The TekScope application takes precedence over other applications, but you can switch to other applications by using the Alt+Tab key combination. To keep the TekExpress SFP+ QSFP+ Tx application on top, select **Keep On Top** from the SFP+ QSFP+ Tx Options menu.

Before you click start

Before you run tests for the first time, do the following:

1. Understand where your test files are stored on the instrument.

After you install and launch TekExpress SFP+ QSFP+ Tx, it creates the following folders on the oscilloscope:

- \My Documents\My TekExpress\SFP+ QSFP+ Tx
- \My Documents\My TekExpress\SFP+ QSFP+ Tx\Untitled Session

Every time you launch TekExpress SFP+ QSFP+ Tx, an Untitled Session folder is created in the SFP-Tx folder. The Untitled Session folder is automatically deleted when you exit the SFP+ QSFP+ Tx application. To preserve your test session files, save the test setup before exiting the TekExpress application.



CAUTION: Do not modify any of the session files or folders because this may result in loss of data or corrupted session files. Each session has multiple files associated with it. When you save a session, a .TekX file, and a folder named for the session that contains associated files, is created on the oscilloscope X: drive.

2. Map the shared My TekExpress folder as X: (X drive) on the instruments used in test setups running Microsoft Windows Operating System.

The My TekExpress folder has the share name format <domain><user ID>My TekExpress. Or, if the instrument is not connected to a domain, the share name format is <instrument name><user ID>My TekExpress. This shared folder is used to save the waveform files and is used during other file transfer operations.



Note: If the X: drive is mapped to any other shared folder, the application will display a warning message asking you to disconnect the X: drive manually.

- 3. Make sure that the My TekExpress folder has read and write access, and that the contents are not set to be encrypted:
 - a. Right-click the folder and select Properties.
 - b. Select the General tab and then click Advanced.
 - c. In the Advanced Attributes dialog box, make sure that the option Encrypt contents to secure data is NOT selected. Example.

General	Sharing	Security	Previous V	ersions	Custor	nize	
	erienig						
	i.						
dvance	d Attrikut	es					
							-
	Choose th	ne settings	; you want f	or this fo	older.		
			or Apply on t				
	asked if y	ou want th	ne changes t	o affect	all subf	ciders and i	riles
A							
Archiv	e and inde	ex attribute	es				
🔲 Fol	der is read	ly for arch	iving				
🔽 Allo			iving to have con	tents ind	dexed in	addition to	file
V Alla	ow files in I operties		to have con	tents inc	dexed in	addition to	file
Compr	ow files in t operties ess or Enc	:his folder rypt attrıb	to have con		dexed in	addition to	file
Compr	ow files in 1 operties ess or Enc mpress cor	, this folder rypt attrib ntents to s	to have con utes ave disk spa		dexed in	addition to	
Compr	ow files in 1 operties ess or Enc mpress cor	:his folder rypt attrib	to have con utes ave disk spa		dexed in		
Compr	ow files in 1 operties ess or Enc mpress cor	, this folder rypt attrib ntents to s	to have con utes ave disk spa	ice		Details	
Compr	ow files in 1 operties ess or Enc mpress cor	, this folder rypt attrib ntents to s	to have con utes ave disk spa	ice	dexed in		
Compr	ow files in 1 operties ess or Enc mpress cor	, this folder rypt attrib ntents to s	to have con utes ave disk spa	ice		Details	

4. See the pre-run checklist before you run a test.

Pre-run checklist

Do the following before you click **Start** to run a test. If this is the first time you are running a test on a setup, refer to the information in *Before you click start*.

- 1. Make sure that all the required instruments are properly warmed up (approximately 20 minutes).
- 2. Perform Signal Path Compensation (SPC).
 - a. On the oscilloscope main menu, select the Utilities menu.
 - b. Select Instrument Calibration.
- 3. Deskew channels.
- 4. Verify that the application is able to find the DUT. If it cannot, perform a search for connected instruments.
 - a. In SFP+ QSFP+ Tx, select the Setup panel and then click the Test Selection tab.
 - b. Select any test and then click Configure.
 - c. In the Configuration section, click Global Settings.

d. In the instruments detected section, click the drop-down arrow to the right of real time scope and make sure that the oscilloscope with the (GPIB8::1::INSTR) designation is in the list.

Starting the application

To start the TekExpress SFP+ QSFP+, select from the oscilloscope menu bar Applications > TekExpress SFP+ QSFP+.

W TekExpress	s SFP+ QSFP+ Tx	- (Untitled)*	Options	8
Setup 1 Status 2 Results 4 Reports 5	DUT) Test Selection) Acquisitions) Configuration) Preferences	DUT ID DUTO1 O Acquire live waveforms Use pre-recorded waveform files View Advanced Standard QSFP+Tx Version SFF-8635 Revision 0.4 Device Profile Host Module 10GSFP+Cu Direct Attach Cable Number of Lanes to Test 1 Lane Selected Test Lanes Lane0		Pause
Stat	us Ready			

During start, a "My TekExpress" folder is created in the Documents folder of the current user and gets mapped to "X" drive. When the application is closed properly, the "X" drive gets unmapped. Session files are then stored inside the $X : \SFP+ QSFP+$ folder. If this file is not found, the application runs an instrument discovery program to detect connected instruments before starting TekExpress SFP+ QSFP+.

To keep the TekExpress SFP+ QSFP+ application on top of any application, select **Keep On Top** from the *options menu*. If the application goes behind the oscilloscope application, select **Applications >TekExpress SFP+ QSFP+** to bring the application to the front.

Application controls

This section describes the application controls with functionality and its details.

Table 5: Application control description

Item	Description
Options menu Options	Menu to display global application controls.
Test panel Setup Status Results Reports	Controls that open tabs for configuring test settings and options.
Start / Stop button	Use the Start button to start the test run of the measurements in the selected order. If prior acquired measurements are not cleared, then new measurements are added to the existing set. The button toggles to the Stop mode while tests are running. Use the Stop button to abort the test.
Pause / Continue button	Use the Pause button to pause the acquisition. When a test is paused, this button changes as Continue .
Clear button	Use the Clear button to clear all existing measurement results. Adding or deleting a measurement, or changing a configuration parameter of an existing measurement, also clears measurements. This is to prevent the accumulation of measurement statistics or sets of statistics that are not coherent. This button is available only on <i>Results panel</i> .
Application window move icon	Place the cursor over the top of the application window to move the application window to the desired location
Minimize icon	Minimizes the application.
Close icon	Close the application.
Table continued	1

Item	Description
	Mini view displays the run messages with the time stamp, progress bar, Start / Stop button, and Pause / Continue button. The application moves to mini view when you click the Start button.

Options menu functions

To access the **Options** menu, click **I** in the upper-right corner of the application. It has the following selections:

Opt	tions	
	Default Test Setup	
	Open Test Setup	
	Save Test Setup	
	Save Test Setup As	
	Open Recent	•
	Instrument Control Settings	
	Keep On Top	
	Email Settings	
	Deskew	
	Help	
	About TekExpress	

Table 6: Options menu settings

Menu	Function
Default Test Setup	Opens a new test setup with default configurations.
Open Test Setup	Opens a previously saved test setup. Displays the list of previously saved test setup file names. Make the selection and click OK to open the test setup.
Save Test Setup	Saves the current test configurations with the specified file name.
Save Test Setup As	Saves the current test setup with a different file name or file type.
Open Recent	Displays the recently opened test setup file names. Make the selection and click OK to open the test setup.
Instrument Control Settings	Detects, lists, and refreshes the connected instruments found on the specified connections (LAN, GPIB, USB, Serial, Non-VISA Resources, TekLink, and VXI).
Keep On Top	Always keeps the TekExpress SFP+ QSFP+ application on top of all the applications.
Email Settings	Configures email options for test run and result notifications.
Deskew	Loads oscilloscope channel deskew settings into the application.
Help	Displays the TekExpress SFP+ QSFP+ help.
Table continued	· · · · ·

Menu	Function
About TekExpress	Displays the application name, version, and hyperlink to end the user license agreement.

Configure email settings

Use the **Email Settings** utility to get notified by email when a measurement completes or produces any error condition. Follow the steps to configure email settings:

ť*		
Email Settings		
Recipient e-mail Address(es)		
	Note: Separate Ernail addresses v	with a comma
Sender's Address		
Email Attachments		Server Configuration
Reports		SMTP Server SMTP Port 0
🖌 Status Log 💿 Last 20 Lir	nes 🔵 Full Log	Login
		Password
		Enable SSL
Email Configuration		
Max Email Size (MB) 5		Number of Attempts to Send 1
Timeout (Sec) 0]	
		Test
Email Test Results When co	mplete or on error	Email Apply Close

Figure 1: Email settings window

- 1. Select Options > Email Settings to open the Email Settings dialog box.
- 2. (Required) For **Recipient email Address(es)**, enter one or more recipient email addresses. To include multiple addresses, separate the addresses with commas.
- (Required) For Sender's Address, enter the email address used by the instrument. This address consists of the instrument name, followed by an underscore, followed by the instrument serial number, then the @ symbol, and the email server ID. For example: user@yourcompany.com.
- 4. (Required) In the Server Configuration section, type the SMTP Server address of the Mail server configured at the client location, and the SMTP Port number, in the corresponding fields.

If this server requires password authentication, enter a valid login name, password, and host name in the corresponding fields.

Note: If any of the above required fields are left blank, the settings will not be saved, and email notifications will not be sent.

- 5. In the Email Attachments section, select from the following options:
 - Reports: Select to receive the test report with the notification email.
 - Status Log: Select to receive the test status log with the notification email. If you select this option, then also select whether you want to receive the full log or just the last 20 lines.
- 6. In the Email Configuration section:
 - Enter a maximum file size for the email message. Messages with attachments larger than this limit will not be sent. The default is 5 MB.
 - Enter the number in the Number of Attempts to Send field, to limit the number of attempts that the system makes to send a notification. The default is 1. You can also specify a timeout period.
- 7. Select the **Email Test Results When complete or on error** check box. Use this check box to quickly enable or disable email notifications.
- 8. To test your email settings, click **Test Email**.
- 9. To apply your settings, click **Apply**.
- 10. Click Close when finished.

TekExpress instrument control settings

Use the **TekExpress Instrument Control Settings** dialog box to search the instruments (resources) connected to the application. You can use the **Search Criteria** options to search the connected instruments depending on the connection type. The details of the connected instrument is displayed in the Retrieved Instruments window.

To access, click **Options > Instrument Control Settings**. Select **GPIB** as search criteria for TekExpress application and click **Refresh**. The connected instruments displayed in the Retrieved Instruments window and can be selected for use under Global Settings in the test configuration section.

Figure 2: TekExpress Instrument Control Settings window

LAN	🗸 gpib	Serial	Non - VISA Resour	rces			
TekLink	USB	VXI			Refresh	TekVISA Timeout	300
Retrieved Inst	rument	s(1)					
Connection		Resource	Serial No	Options		Resource A	ddr
VISA-GPIB		DPO73304SX	QU000053	10XL,PTH	1,ASM,E	GPIB8::1::INS	

See also

Options menu functions on page 28

Setup panel: Configure the test setup

The Setup panel contains sequentially ordered tabs that help you guide through the test setup and execution process.

TekExpress SFP+ QSFP+ T	< - (Untitled)*	Options 🔹	۷
Setup 1 DUT 2 Test Selection 3 Acquisitions 4 Preferences	DUT ID OLT ID O Acquire live waveforms Use pre-recorded waveform files View Compliance Standard QSFP+Tx Version SFF-8635 Revision 0.4 Device Profile Image: Compliance Image: Compliance	Y	Pause
Status Ready			

Figure 3: DUT tab, QSFP+ Tx compliance view



Figure 4: DUT tab, QSFP+ Tx advanced view

			Sta
Setup 1 D	UT DL	DUTOO1 🧭	
	est Selection	Acquire live waveforms OUse pre-recorded waveform files	
Status	Vie	ew Compliance 🔽	Pau
Results 3 A	cquisitions Sta	andard SFP+Tx Version SFF-8431 Revision 4.1	
Reports 4 P	references De	vice Profile	
	0) Host 🔘 Module	
		10GSFP+Cu Direct Attach Cable	

Figure 5: DUT tab, SFP+ Tx compliance view

DUT: Set DUT settings

Use the DUT tab to select parameters for the device under test. These settings are global and apply to all tests of current session. DUT settings also affect the list of available tests in the Test Selection tab.

KTekExpress SFP+ QSFP+	Tx - (Untitled)*	Options	×
Y TekExpress SFP+ QSFP+ Setup 1 DUT 2 Test Selection 3 Acquisitions 4 Configuration 5 Preferences	DUT ID DUT001	Vptions	Pause
Status Ready			

Figure 6: DUT tab

Click Setup > DUT to access the DUT parameters:

Table 7: DUT tab configuration

Setting	Description			
DUT ID	Adds an optional text label for the DUT to reports. The default value is DUT001. The maximum number of characters supported is 32. You cannot use the characters $(.,,,h,/:?"<> *)$ in an ID name.			
Comments icon (to the right of the DUT ID field)	Opens a comments dialog box which allows you to enter optional text to add to a report. You can enter a maximum number of 256 characters. Refer <u>Select report generation</u> Options on page 47 to enable or disable comments which displays on the test report.			
Acquire live waveforms	Acquire active signals from the DUT for measurement and analysis.			
Use prerecorded waveform files	Run tests on a saved waveform. Also refer Load a saved test setup.			
View	Select the View type from the drop-down:			
	Compliance			
	Advanced			
	Note: If you select Advanced View, the configuration settings are included in the Setup steps. If you select Compliance View, the configuration step is not included as a			

Table continued...

Setting	Description			
	separate step. Access configuration parameters for selected tests from the Configure button in the Test Selection tab.			
Standard	Select the mode from the drop-down:			
	• SFP+ Tx			
	• QSFP+ Tx			
Version	Displays the version of testing specification			
Host	Select this option to enable Host tests listed in the Test Selection tab. To include measurements related to an attached copper cable, select the 10GSFP+Cu Direct Attach Cable check box.			
	Note: The Host device profile is enabled by default.			
Module	Select this option to enable Module tests listed in the Test Selection tab.			
Number of Lanes to Test	Select the Number of Lanes to Test from the drop-down			
	• 1 Lane			
	2 Lanes			
	• 4 Lanes			
Selected Test Lanes	Click the Selected Test Lanes Setup button to open the Test Lane Setup dialog. Use the dialog to configure which lanes to test.			
	Test Lane Setup Link Width 1 Lane Select the lanes to test Lane0 Lane1 Lane2 Lane3			

Test Selection: Select the tests

Use the Test Selection tab to select the tests. The test measurements available depends on the settings selected in the DUT tab.

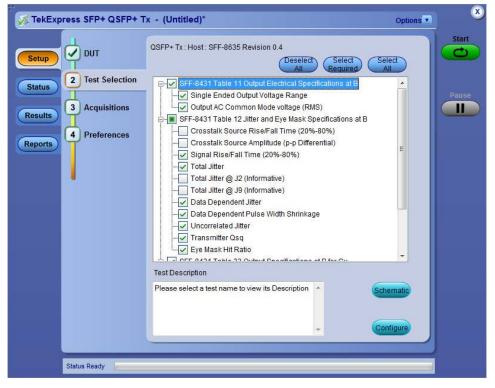


Figure 7: Test selection tab

Setting	Description
Deselect All, Select All	Deselect or select all tests in the list.
Select Required	Selects all test required to pass compliance.
Schematic	Displays equipment connection setup for the selected measurements. You need to select at least a measurement before you click the Schematic.
Configure	When the View type selected in the DUT tab is Compliance, this button opens the configuration section for the selected test. If the View type is Advanced, this button is not displayed.
Test selection field	Lists available test and if they are selected to run. Click in the box adjacent to a test to select or unselect a test.
Test Description	Shows a description of the selected test.

Acquisitions: Set waveform acquisition settings

Use Acquisitions tab to view the test acquisition parameters. The contents displayed on this tab depends on the DUT type and the tests selected.

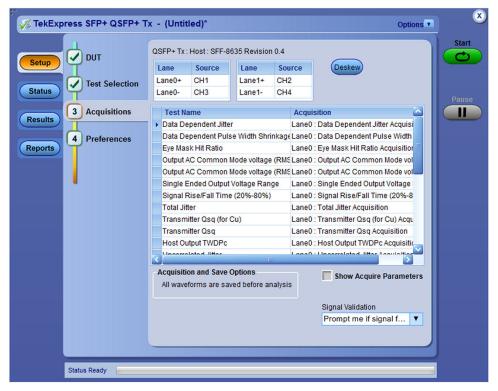




Table 9: Acquisitions tab configuration

Setting	Description
Data Source (+), Data Source (-)	Sets the channels used for positive and negative data sources. When QSFP+ Tx is the selected standard, data sources for each lane to be tested can be configured.
Deskew	Provides the option of setting deskew values on the scope either in an automated way or manual way.
Test Name	Displays the name of the selected test to which the acquisitions apply. One or more tests can perform the same acquisitions.
Acquisition	The acquisition of the waveform for the corresponding test
Signal Type	Shows the acquisition parameters of the signal. This column is displayed only if the Show Acquire Parameters check box is selected in the Acquisition and Save Options section.
Waveform File	Lists the name of the waveform files used for the test. Select waveform files by clicking the button in the row and selecting any waveform file using the standard File Open window. This option is available only when Use pre-recorded waveform files is selected in the Setup panel DUT tab.
Acquisition and Save Options	All waveforms are saved before analysis.
Table continued	

Setting		Description		
Show Acquire Para	meters	When selected, the signal acquisition parameter for each test displays in the Signal Type column.		
Signal Validation		Determines how the application responds to the source signal Note: Signal validation is valid only for Live acquisitions		
	Prompt me if signal fails	If the signal fails, pauses the measurement operation and displays a dialog box with the following options:		
		Signal Validation Failed		
		Invalid Signal, what do you wish to do?		
		Continue Skip Test ReAcquire		
		Reacquire: Try acquiring the signal again.		
		 Use Anyway: Use the signal even if it cannot be validated. 		
		• Skip Test: Abort the test if the signal cannot be validated.		
	Use signal as is - Don't Check	Skips the signal validation process. Does not test the signal for its characteristics		
	Skip test if signal fails	Moves to the next test (if applicable) if the signal fails		

TekExpress SFP+ QSFP+ application saves all acquisition waveforms to files by default. Waveforms are saved in a unique folder for each session (a session is started when you click the Start button). The folder path is X:\TekExpress SFP+ QSFP+\Untitled Session\<dutid>\<date>_<time>. Images created for each analysis, XML files with result values, reports, and other information specific to that particular execution are also saved in this folder.

Saving a session moves the session file contents from the Untitled Session folder to the specified folder name and changes the session name to the specified name.

Configuration: Set measurement limits for tests

Use Configuration tab to view and configure the Global Settings and the measurement configurations. The measurement specific configurations available in this tab depends on the selections made in the DUT panel and Test Selection panel.



Note: The Use Filter File for De-embedding (only for TWDPC) check box is available only if the test Host Output TWDPC is selected in the Test Selection tab.



Note: If you change the channel selection for Data+ (DP) and Data– (DN) signals, make sure that you change the corresponding trigger source in the Analyze tab for each of the measurements. If you do not do this, the waveform might not trigger and the measurements might not be completed.

Table 10: Configuration tab: Common parameters

Settings	Descriptio	n					
Limit Editor	Displays th	e upper a	and lowe	r limits f	or the appl	icable ı	measurement using different types of comparisons.
	Limits Editor						8
	View or Edit the v A blank cell means			ow Limt for ea	ch measurement		
	Test Name	Details	Compare String	Low Limit	Compare String	High Limit	
	Crosstalk Source	Crosstalk Source A	== Equal To	1000			
	Crosstalk Source	Crosstalk Source Ri	Equal To	34			
	Crosscaik Source	Crosstalk Source Fa	== Equal To	34			
	Data Dependent	Data Dependent 3k	< Less Than	0.1	> Greater Than	1.0	
	Data Dependent	Data Dependent Pu	< Less Than	0.055	> Greater Than		
	Eye Mask Hit Ratio		< Less Than	Se-5	< Less Than		
		Signal Rise Time (pS)		34	>= Greater Than Or <= Less Than Or Eq		
		Signal Fall Time (pS)		34	Cess manor by	ano	
	Total Jitter	Total Jitter (UI)	< Less Than	0.28			



Figure 9: Configuration tab: Global Settings

Table 11: Configuration tab: Global Settings configuration

Setting	Description
Compliance Mode	Select to use Compliance Mode values. You cannot change most test parameters in Compliance mode but you can view the parameters.
User Defined Mode	Select to run tests with custom parameters.
Instruments Detected	Displays the instruments connected to this application. Click on the instrument name to open a list of available (detected) instruments. Select Options > Instrument Control Settings to refresh the connected instrument list refer TekExpress instrument control settings.
Record Length	Specifies the length of the record (5M is the default)
Data Rate	Select the signal data rate as one of 9.95328 Gbps, 10.3125 Gbps (default), 10.51875 Gbps, or 11.10 Gbps.
Use Filter File for De-embedding (All Test except TWDPC)	When selected, provides a browse button and field for selecting a filter to use to compensate for cable lengths.
Use Filter File for De-embedding for TWDPC	When selected, provides a browse button and field for selecting a filter to use to compensate for cable lengths.

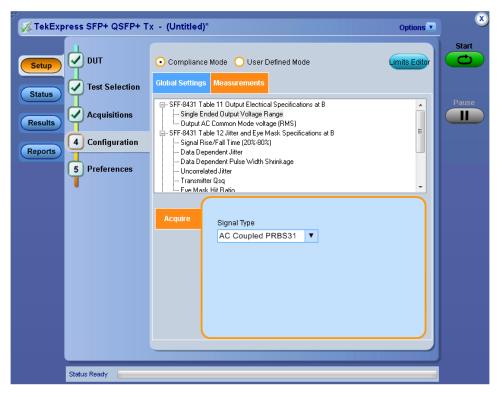


Figure 10: Configuration tab: Measurement

Setting	Description
Measurements	
Table continued	

Setting		Description	
Acquire			
	Signal Type	Specifies the signal type of the acquisition for the test selected in the tree view of the Measurements tab. Running tests in User Defined Mode allows you to perform the tests on different types of signal. The default signal type varies by test. Not all tests support all the signal types. For each test, the application includes the signal type options that are best suited to the measurements.	
	Window Size (%)	Host test Transmitter Qsq only. Set at 10% for Compliance Mode. In User Defined Mode, you can change this to 5% or 20%.	

Preferences: Set the test run preferences

Use **Preferences** tab to set the application action on completion of a measurement. The **Preferences** tab has the feature to enable or disable certain options related to the measurement execution.

TekExpress SFP+ QSFP+	Tx - (Untitled)	Options	8
Setup Status Results Reports	Analysis Options	Email Settings	Pause
Status Ready			

Figure 11: Preferences tab

Refer the below table for the options available in the **Preferences** tab:

Table 13: Preferences tab settings

Setting	Description
	Select to stop the test run on Test Failure, and to get notified via email. By default, it is unselected. Click Email Settings to configure the email settings to receive notifications.

Status panel: View the test execution status

The Status panel contains the **Test Status** and **Log View** tabs, which provides status on the test acquisition and analysis (Test Status) and listing of test tasks performed (Log View tab). The application opens the **Test Status** tab when you start to execute the test. Select the **Test Status** or the **Log View** tab to view these items while the test execution is in progress.

View test execution status

The tests are grouped and displayed based on the Clock and Data lane. It displays the tests along with the acquisition type, acquire, and analysis status of the tests. In pre-recorded mode, **Acquire Status** is not valid.

The **Test Status** tab presents a collapsible table with information about each test as it is running. Use the symbols to expand (¹¹) and collapse (¹¹) the table rows.

	est Name	Acquisition	Acquire Status	Analysis Status
8	Lane0			
	Single Ended Output Voltage Range	Single Ended Output Voltage Range Acquisition		To be started
	Output AC Common Mode voltage (RMS)	Output AC Common Mode voltage (RMS) Acquisition	To be started	To be started
	Signal Rise/Fall Time (20%-80%)	Signal Rise/Fall Time (20%-80%) Acquisition	To be star.ed	To be started
	Data Dependent Jitter	Data Dependent Jitter Acquisition	To be started	To be started
	Data Dependent Pulse Width Shrinkage	Data Dependent Pulse Width Shrinkage Acquisition	To be starred	To be started
	Uncorrelated Jitter	Uncorrelated Jitter Acquisition	To be started	To be started
	Transmitter Qsq	Transmitter Qsq Acquisition	To be started	To be started
	Eye Mask Hit Ratio	Eye Mask Hit Ratio Acquisition	To be started	To be started
	Voltage Modulation Ampltude (p-p)	Voltage Modulation Amplitude (p-p) Acquisition	To be starred	To be started
	Transmitter Qsq (for Cu)	Transmitter Qsq (for Cu) Acquisition	To be stared	To be started
	Output AC Common Mode voltage (RMS) (for Cu)	Output AC Common Mode voltage (RMS) (for Cu) Acquisition	To be started	To be started
	Host Output TV/DPc	Host Output TV/DPc Acquisition	To be started	To be started



Table 14:	Test execution	status	table	headers
-----------	----------------	--------	-------	---------

Table Header	Description
Test Name	Displays the measurement name.
Acquisition	Describes the type of data being acquired.
Acquire Status	Displays the progress state of the acquisition:
	To be started
	Completed Acquisition
	Prerecorded waveform
Table continued	

Description
Displays the progress state of the analysis: To be started In progress Completed Aborted

View test execution logs

The Test Status tab displays the detailed execution status of the tests. Also, displays each and every execution step in detail with its timestamp information. The log details can be used to troubleshoot and resolve any issue/bug which is blocking the test execution process.

	Test Status Log View			Sta
etup		Message History	V Show Detailed Log	
esuits ports	05/21/13 01:40:57: MSO72004C 05/21/13 01:40:57: Scope Addre 05/21/13 01:40:57: Scope Model 05/21/13 01:40:57: DOUBL Versi 05/21/13 01:40:57: Oblev Versi 05/21/13 01:40:57: GetSelected 05/21/13 01:40:57: Selected 05/21/13 01:40:57: Selected 05/21/13 01:40:57: Selected 05/21/13 01:40:58: DN_SOURCE 05/21/13 01:40:58: DN_SOURCE 05/21/13 01:40:58: DN_SOURCE 05/21/13 01:40:58: Lane selected 05/21/13 01:40:58: Signal Type L 05/21/13 01:40:58: Total Signal 1	35 Revision 0.4 013-05-2101-4057.756000 tst.PRE_RECORDED_MODE : False (GPI88:1::INSTR) sv: GPI88:1::INSTR : MS072004C stuld 3 on :"6.0.1 Build 8" Number : (220691 atus : PASS ests: :[Single Ended Output Voltage Range', 'Output AC : CH1 : CH3 IDATION_VALUE : Prompt me if signal fails : Lane0 : Eid4d Output Voltage Range', 'Output AC Common N Eid42 Output Voltage Range', 'Output AC Common N	Common Mode voltage (RMS)', 'S 1ode voltage (RMS)', 'Signal Rise/	
	•			
	Auto Scroll		Clear Log Save	

Figure 13: Log view in Status panel

Table 15: Status panel settings

Control	Description
Message History	Lists all the executed test operations and timestamp information.
Auto Scroll	Enables automatic scrolling of the log view as information is added to the log during the test execution.
Clear Log	Clears all the messages from the log view.
Save	Saves the log file into a text file format. Use the standard Save File window to navigate to and specify the folder and file name to save the log text.
Show Detailed Log	Select the check box to record a detailed history of test execution.

Results panel: View summary of test results

When a test execution is complete, the application automatically opens the Results panel to display a summary of test results.

In the Results table, each test result occupies a row. By default, results are displayed in summary format with the measurement details collapsed and with the Pass/Fail column visible.

Overall Test Re	sult Live				Preferen	ces v
Description)	Details	Pass/Fail	Value	Margin	
	al Rise/Fall (20%-80%)	Signal Rise/Fall Time (20%-80%) RiseTime	🞯 Pass	52.9379	18.9379	
High	n Limit		N.A	N.A		
Low	Limit		🥑 Pass	34.0		
	al Rise/Fall (20%-80%)	Signal Rise/Fall Time (20%-80%) FallTime	🥝 Pass	46.9951	12.9951	
High	n Limit		N.A	N.A		
Low	Limit		📀 Pass	34.0		
🖃 Pulse	Dependent Width Ikage	Data Dependent Pulse Width Shrinkage	🥑 Pass	0.0156	0.0394	
High	n Limit		🥑 Pass	0.055		
Low	Limit		N.A	N.A		
🖃 Unco	rrelated Jitter	Uncorrelated	Pass	0.0041	0.0189	
High	n Limit		🥝 Pass	0.023		
Low	Limit		N.A	N.A		=
🕀 Trans	smitter Qsq	Transmitter Qsq	Pass	142.8168	92.8168	
⊕ Volta Modu	ge Ilation	Voltage Modulation	🥝 Pass	497.4027	197.4027	
⊕ Trans (for C	smitter Qsq Cu)	Transmitter Qsq (for Cu)	🥑 Pass	142.8168	79.7168	
⊕ Host TWD	Output Pc	Host Output TWDPc	📀 Pass	10.3854	0.3146	

Figure 14: Results panel with measurement results



Note: Results of Crosstalk measurements, Total Jitter @ J2, and Total Jitter @ J9 are not included in the Overall Test Results because these measurements are informative only. If any of the Crosstalk tests or Total Jitter @ J2 and Total Jitter @ J9 fails, it will not cause the overall test results to fail.

Click sicon on each measurement in the row to expand and to display the minimum and maximum parameter values of the measurement.

Filter the test results

Each column in the result table can be customized and displayed by enabling or disabling any column as per your requirement. You can change the view in the following ways:

- To remove or restore the Pass/Fail column, select Preferences > Show Pass/Fail.
- To collapse all expanded tests, select Preferences > View Results Summary.
- To expand all the listed tests, select View Results Details from the Preferences menu in the upper right corner.
- To enable or disable the wordwrap feature, select Preferences > Enable Wordwrap.
- To view the results grouped by lane or test, select the corresponding item from the Preferences menu.
- To expand the width of a column, place the cursor over the vertical line that separates the column from the column to the right. When the cursor changes to a double-ended arrow, hold down the mouse button and drag the column to the desired width.
- To clear all test results displayed, click Clear.

Reports panel: Configure report generation settings

Click Reports panel to configure the report generation settings and select the test result information to include in the report. You can use the Reports panel to configure report generation settings, select test content to include in reports, generate the report, view the report, browse for reports, name and save reports, and select report viewing options.

Select report generation options

This section describes the report generation settings you can configure in the Reports panel. Select report settings before running a test or when creating and saving test setups. Report settings configured are included in saved test setups.

💞 TekExp	ress SFP+ QSFP+ Tx - (Untitled)	Options	۷
	Report Generation		Start
Setup	• Generate new report		C
	O Append with previous run session		
Status	O Replace current test results in previous run session		
			Pause
Results	Report name X:\SFP+ QSFP+ Tx\Reports\DUT001.r Browse		
	Save as type Web Archive (*.mht;*.mhtml)		
Reports			
	✓ Auto increment report name if duplicate		
	Contents To Save Group Test Results by		
	Include detailed results Lane		
	V Include plot images		
	✓ Include setup configuration		
	✓ Include user comments		
	View View February View		
	Report	ave As	
	Status Ready		



Report Update Mode Settings

Table 16: Report Update Mode Settings

Control	Description
Report Generation	
Generate new report	Each time when you click Run and when the test execution is complete, it will create a new report. The report can be in either .mht, .pdf, or .csv file formats.
Append with previous run session	Appends the latest test results to the end of the current test results report. Each time when you click this option and run the tests, it will run the previously failed tests and replace the failed test result with the new pass test result in the same report.
Replace current test in previous run session	Replaces the previous test results with the latest test results. Results from newly added tests are appended to the end of the report.
Table continued	

Control	Description
Report name	Displays the name and path of the TekExpress SFP+ QSFP+ report. The default location is at \My Documents>\My TekExpress\SFP+ QSFP+\Reports. The report file in this folder gets overwritten each time you run a test unless you specify a unique name or select to auto increment the report name.
	To change the report name or location, do one of the following:
	 In the Report Path field, type the current folder path and name. Double-click in the Report Path field and then make selections from the popup keyboard and click Enter.
	Be sure to include the entire folder path, the file name, and the file extension. For example: C:\Documents and Settings\your user name\My Documents\My TekExpress\SFP+ QSFP+\DUT001.mht.
	Note: You cannot set the file location using the Browse button.
	Open an existing report
	Click Browse , locate and select the report file and then click View at the bottom of the panel.
Save as type	Saves a report in the specified file type, selected from the drop-down list. The report is saved in .csv, .pdf, or .mht.
	Note: If you select a file type different from the default, be sure to change the report file name extension in the Report Name field to match.
Auto increment report name if duplicate	Sets the application to automatically increment the name of the report file if the application finds a file with the same name as the one being generated. For example: DUT001, DUT002, DUT003. This option is enabled by default.
Contents To Save	
Include pass/fail results summary	Select to include pass/fail information in the details table of the report.
Include detailed results	Select to include detailed results in the report.
Include plot images	Select to include the plot images in the report.
Include setup configuration	Sets the application to include hardware and software information in the summary box at the top of the report. Information includes: the oscilloscope model and serial number, the oscilloscope firmware version, and software versions for applications used in the measurements.
Include user comments	Select to include any comments about the test that you or another user have added in the DUT tab of the Setup panel. Comments appear in the Comments section, below the summary box at the beginning of each report.
Group Test Results by	· · ·
Test Name	Select to group the test results based on the test name in the report.
Lane	Select to group the test results based on the Lanes in the report
Other settings in report panel	
View report after generating	Automatically opens the report in a Web browser when the test execution is complete. This option is selected by default.

Control	Description
View	Click to view the most current report.
Generate Report	Generates a new report based on the current analysis results.
Save As	Specify a name for the report.

View a generated report

Sample report and its contents

A report shows detailed results and plots, as set in the Reports panel.

Tektroni	X		TekExp	oress QSFP-			
			Host	Test Report			
Setup Information							
DUT ID		DUT001		TakEypross Vo	rsion SFP+/QSFP+	3.1.0.126	
Spec Version		SFF-8635 Revis	ion 0.4	Scope Model	131011 311 +/ Q311 +	DP072004C	
Date/Time		2013-10-16 05		FW Version		6.8.1 Build 3	
Compliance Mode		True		DPOJet Version	Ê.	6.1.0.509	
Overall Execution	Time	0:16:09		Scope Serial Nu	imber	B130233	
Overall Test Resul	t	Pass		Calibration Sta	tus	PASS	
DUT COMMENT:	General	Comment – QSFP + Tra	nsmitter Host DU	T			
Single Ended Outpu	ut Voltage Rai	nge			_		
Measurement				(
Details Single Ended	Lane	Measured Value	Units	Test Result	Margin	High Limit	Low Limit
Output Voltage Range Min(V)	Lane0	-0.1818	v	Pass	0.1182	N.A	-0.3
Single Ended Output Voltage Range Max(V)	Lane0	0.162	V	Pass	3.838	4.0	N.A
Single Ended Output Voltage Range Min(V)	Lanel	-0.1776	V	Pass	0.1224	N.A	-0.3
Single Ended Output Voltage Range Max(V)	Lanel	0.1584	v	Pass	3.8416	4.0	N.A
COMMENTS		Signal Type :AC Couple	d PRBS31.	<u> </u>	/		
							Back to Summary Tab
Test Name Summar							
Single Ended Outpu				Pass			
Output AC Commo	n Mode volta	ge (RMS)		Pass			
Transmitter Qsq				Pass			
Eye Mask Hit Ratio				Pass			
Voltage Modulation Transmitter Qsg (fo		<u>p-p)</u>		Pass Pass			
Output AC Commo		no (PMS) (for Cu)		Pass			
Host Output TWDP				Pass			
Single Ended Outpu	it Voltage Rar	ide					
Measurement Detai	ils Measured		Test	Result Marg	in Hi	gh Limit	Low Limit
Single Ended Outpu Voltage Range Min (V)		V	Pass	0.12	24 N.J	4	-0.3
Single Ended Outpu Voltage Range Max (V)		v	Pass	3.84	4.0)	N.A
COMMENTS	-	Signal Type :AC Coupled	d PRBS31.				
							Back to Summary Tab
Output AC Commo							
Measurement Detai		Value Units	Test	Result Marg	in Hi	gh Limit	Low Limit
Output AC Commo Mode voltage (RMS)		mV	Pass	6.809	92 15	.0	N.A
COMMENTS	5	ignal Type :PRBS31					
							Back to Summary Tab

Figure 16: Report

Setup Information	The summary box at the beginning of the report lists setup configuration information. This information includes the oscilloscope model and serial number, optical module model and serial number, and software version numbers of all associated applications.
Test Name Summary Table	The test summary table lists all the tests which are executed with its result status.
Measurement	The measurement table displays the measurement related details with its parameter value.
User comments	If you had selected to include comments in the test report, any comments you added in the DUT tab are shown at the top of the report.

Saving and recalling test setup

Overview

You can save the test setup and recall it later for further analysis. Saved setup includes the selected oscilloscope, general parameters, acquisition parameters, measurement limits, waveforms (if applicable), and other configuration settings. The setup files are saved under the setup name at X:\TekExpress SFP+ QSFP+

Date modified	Туре
3/31/2021 9:06 PM	File folder
3/31/2021 10:05 PM	File folder
3/31/2021 10:35 PM	File folder
3/31/2021 10:48 PM	File folder
3/31/2021 11:02 PM	File folder
3/31/2021 11:08 PM	File folder
	3/31/2021 9:06 PM 3/31/2021 10:05 PM 3/31/2021 10:35 PM 3/31/2021 10:48 PM 3/31/2021 11:02 PM

Figure 17: Example of Test Setup File

Use test setups to:

- Recall a saved configuration.
- Run a new session or acquire live waveforms.
- Create a new test setup using an existing one.
- View all the information associated with a saved test, including the log file, the history of the test status as it executed, and the results summary.
- · Run a saved test using saved waveforms.

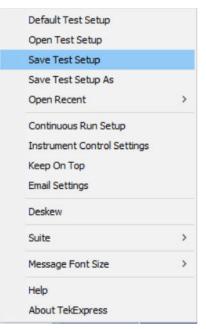


Note: Images that are shown in this Saving and recalling test setup chapter are for illustration purpose only and it may vary depending on the TekExpress application.

Save the configured test setup

You can save a test setup before or after running a test. You can create a test setup from already created test setup or using a default test setup. When you save a setup, all the parameters, measurement limits, waveform files (if applicable), test selections, and other configuration settings are saved under the setup name. When you select the default test setup, the parameters are set to the application's default value.

• Select **Options > Save Test Setup** to save the opened setup.



•

Select **Options > Save Test Setup As** to save the setup with different name.

Default Test Setup	
Open Test Setup	
Save Test Setup	
Save Test Setup As	
Open Recent	>
Continuous Run Setup	
Instrument Control Settings	
Keep On Top	
Email Settings	
Deskew	
Suite	>
Message Font Size	>
Help	
About TekExpress	

Load a saved test setup

To open (load) a saved test setup, do the following:

• Select Options > Open Test Setup.

Default Test Setup	
Open Test Setup	
Save Test Setup	
Save Test Setup As	
Open Recent	>
Continuous Run Setup	
Instrument Control Settings	
Keep On Top	
Email Settings	
Deskew	
Suite	>
Message Font Size	>
Help	
About TekExpress	

• From the File Open menu, select the setup file name from the list and click Open.

1 22 - 10 - 20 20190927_160917 19 - 09 - 20 20190927_161012 06 - 10 - 20 20190927_161308 01 - 09 - 20 20190927_161731 05 - 09 - 20 20190927_163152 01 - 09 - 20 20190927_172309 01 - 09 - 20 20190927_172805 01 - 09 - 20	- 09 - 2021 - 10 - 2021 - 09 - 2021 - 09 - 2021 - 09 - 2021 - 09 - 2021
20190927_161012 06 - 10 - 20 20190927_161308 01 - 09 - 20 20190927_161731 05 - 09 - 20 20190927_163152 01 - 09 - 20 20190927_172309 01 - 09 - 20	- 10 - 2021 - 09 - 2021
20190927_161308 01 - 09 - 20 20190927_161731 05 - 09 - 20 20190927_163152 01 - 09 - 20 20190927_172309 01 - 09 - 20	- 09 - 2021 - 09 - 2021 - 09 - 2021 - 09 - 2021 - 09 - 2021
20190927_161731 05 - 09 - 20 20190927_163152 01 - 09 - 20 20190927_172309 01 - 09 - 20	- 09 - 2021 - 09 - 2021 - 09 - 2021
20190927_163152 01 - 09 - 20 20190927_172309 01 - 09 - 20	- 09 - 2021 - 09 - 2021
20190927_172309 01 - 09 - 20	- 09 - 2021
20100027 172005 01 00 20	
20190927_172005	- 09 - 2021
20190927_173112 01 - 09 - 20	- 09 - 2021
20190927_173448 01 - 09 - 20	- 09 - 2021
BackwardCompitability 27 - 10 - 20	- 10 - 2021

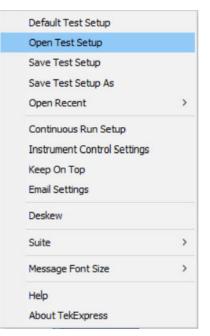


Note: Parameters that are set for the respective test setup will enable after opening the file.

Perform a test using pre-run session files

Complete the following steps to load a test setup from a pre-run session:

1. Select Options > Open Test Setup.



2. From the File Open menu, select a setup from the list and then click Open.

File Name	Saved On
1	22 - 10 - 2020
20190927_160917	19 - 09 - 2021
20190927_161012	06 - 10 - 2021
20190927_161308	01 - 09 - 2021
20190927_161731	05 - 09 - 2021
20190927_163152	01 - 09 - 2021
20190927_172309	01 - 09 - 2021
20190927_172805	01 - 09 - 2021
20190927_173112	01 - 09 - 2021
20190927_173448	01 - 09 - 2021
BackwardCompitability	27 - 10 - 2021 📓
ter File Name:	
190927_160917	

 \wedge

Note: Parameters that are set for the respective test setup will enable after opening the file.

3. Switch the mode to Use Pre-recorded waveform files in the DUT panel.

V TekExpress Application Nam	ne - (20190927_161012)	Options	
TekExpress Application Name Setup 1 DUT 2 Test Selection 3 Acquisitions 4 Configuration 9 Preferences	DUT ID DUT001 Acquire live waveforms Acquire live waveforms Use pre-recorded waveform fil Kiew Advanced Session : BackwardCompitability	Ies Spec 1.0 V	Start C
Ready.			

4. Select the required waveforms from the selected setup in the Acquisitions tab and click Start.

V TekExpress Application Nan	ne - (20190927_161012)*	Options	
Setup Status	TX-Device : Group1 : Spec 1.0	Refresh View Probes	Pause
Results 3 Acquisitions Plots 4 Configuration 5 Preferences	Period using SCOPE (Acq Short Record-length fo Period using DPOJET (Ac Short Record-length fo		Pause
Ready.		Show Acquire Parameters	

5. The selected waveform file can be removed/replaced by clicking on the () icon.

Setup DUT TX-Device : Group1 : Spec 1.0	tart
Status	t) nuse
(Results) Test Name Acquisition Waveform File Name	
Configuration Period using SCOPE (Acq Short Record-length for S(X1AnnEmulatoriworstc. Period using DPOJET (Ac Short Record-length for Df Replace Waveform File	
Plots Remove Waveform File	
Reports Select Waveform Files	
Show Acquire Parameters	
Ready.	

6. After successful completion of the test, the waveform report files are stored at X:\<Application Name>\Reports.

Name	Date modified	Туре
DUT001_2266.mht	10/27/2021 4:25 AM	MHTML Document
DUT001_2265.mht	10/27/2021 1:24 AM	MHTML Document
DUT001_2264.mht	10/6/2021 2:58 AM	MHTML Document
DUT001_2263.mht	10/6/2021 2:40 AM	MHTML Document
DUT001_2262.mht	10/6/2021 2:35 AM	MHTML Document
DUT001_2261.mht	10/6/2021 2:23 AM	MHTML Document

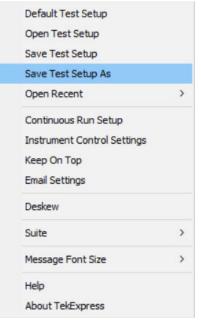
7. The overall test result status after completion of the test execution is displayed in the Results Panel.

Test Name Pass/Fail Iteration Details Value Margin Units Period using SCOPE (Acquire-Analyze Combined) Image: Combined (ps) 1551.1563 L1501.1563 L1501.1563 ps Period using SCOPE (Acquire-Analyze Combined) Image: Combined (ps) 1551.1563 L1501.1563 ns Period using DPOLYET (Acquire-Analyze Combined) Image: Combined (ps) 1551.5535 L1501.5535 ps
Oracle (Acquire-Analyze Combined) Pass H:448.8437 Period using SCOPE Period (ns) 1551.1563 L:1501.1563 ns (Acquire-Analyze Combined) Period using DPOJET Period (ns) 1551.5535 L:1501.15535 ps (Acquire-Analyze Combined) Period using DPOJET 1 Period (ps) 1551.5535 L:1501.5535 ps (Acquire-Analyze Image: Pass Device Combined) Period (ps) 1551.5535 L:1501.5535 ps (Acquire-Analyze Image: Pass Device Combined) Image: Pass Device Combined) Image: Pass Device Combined Period (ps) 1551.5535 L:1501.5535 ps
🗈 (Acquire-Analyze 🛛 🐼 Pass H:448.4465
•

Save the test setup with a different name

To save a test setup with a different name, follow the steps:

1. Select Options > Save Test Setup As.



2. Enter the new test setup name and click Save.



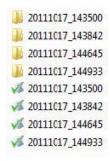
Run a saved test in prerecorded mode

Use this option to rerun a complete test using just the oscilloscope and the saved test setup files, provided that you selected to save the captured waveforms when you originally ran the saved test.



Note: When you run a saved test in prerecorded mode and then save it under the same name, the test results are saved in a new session folder named for the date and time of the session. Any test settings that you changed for the session will be saved as a new test session file and be paired with a folder of the same name. Example. When you open a test setup that has multiple

sessions and you select a session from the Run session list in the DUT tab, the settings associated with that test session are restored.



Each test session folder has a matching test session file that stores the individual test settings for that session.

- 1. Open a saved test setup.
- 2. In the Setup panel, select the DUT tab and then select Use pre-recorded waveform files.

A Run session drop-down list appears that displays the previous saved sessions for this test.

3. From the Run session list, select the session to run.

Note: If you select a session for which no waveform files were saved, you will receive an error message. Either select another test session or select waveform files to use. For details, see Step 2 of Select Acquisitions.

- 4. Click Start.
- 5. To save the test results, session settings, and related files, save the test setup before selecting another test setup or exiting TekExpress SFP+ QSFP+ Tx.

SCPI Commands

About SCPI command

You can use the Standard Commands for Programmable Instruments (SCPI) to communicate remotely with the TekExpress application. Complete the TCPIP socket configuration and the TekVISA configuration in the oscilloscope or in the device where you are executing the script.



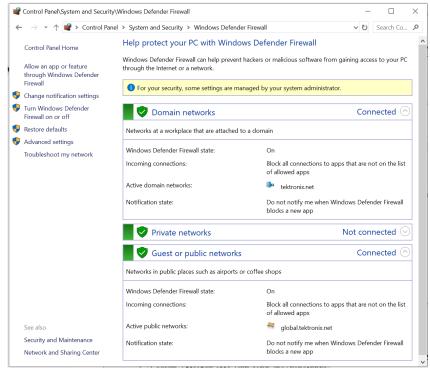
Note: If you are using an external PC to execute the remote interface commands, then install TekVISA in the PC to make the configurations.

Socket configuration for SCPI commands

This section describes the steps to configure the TCPIP socket configuration in your script execution device and the steps to configure the TekVISA configuration in the oscilloscope to execute the SCPI commands.

TCPIP socket configuration

1. Click Start > Control Panel > System and Security > Windows Firewall > Advanced settings.



2. In Windows Firewall with Advanced Security menu, select Windows Firewall with Advanced Security on Local Computer > Inbound Rules and click New Rule...

• 🔶 🙇 🖬 🗟 🖬						
Windows Defender Firewall with	Inbound Rules			_		Actions
Cutbound Rules	Name	Group	Profile	Enabled	Action ^	Inbound Rules
🌆 Connection Security Rules						🚉 New Rule
Nonitoring						Filter by Profile
						Filter by State
						Y Filter by Group
						View
						Refresh
						🗟 Export List
						Help
						- ·

3. In New Inbound Rule Wizard menu

a.	Select	Port	and	click	Next.
----	--------	------	-----	-------	-------

🔗 New Inbound Rule Wizard	d	×
Rule Type		
Select the type of firewall rule to c	create.	
Steps:		
Rule Type	What type of rule would you like to create?	
Protocol and Ports		
Action	O Program	
Profile	Rule that controls connections for a program.	
Name	e Port	
	Rule that controls connections for a TCP or UDP port.	
	O Predefined:	
	@FirewallAPI.dll,-80200	
	Rule that controls connections for a Windows experience.	
	⊖ Custom	
	Custom rule.	
	< Back Next > Cancel	

b. Select TCP as rule apply, enter 5000 for Specific local ports and click Next.

Public Type Protocol and Pots Action Profile Name Does this rule apply to all local pots or specific local pots? All local pots © Specific local pots: \$00 Example: 80, 443, 5000-5010	One site the protocols and a set	a which this sule applie -					
Pade Type Does this rule apply to TCP or UDP? Image: TCP UDP Does this rule apply to all local ports or specific local ports? Image: Name Does this rule apply to all local ports or specific local ports? Image: Name Does this rule apply to all local ports or specific local ports? Image: Name Does this rule apply to all local ports or specific local ports? Image: Name Does this rule apply to all local ports or specific local ports? Image: Name Does this rule apply to all local ports or specific local ports? Image: Name Does this rule apply to all local ports or specific local ports? Image: Name Specific local ports Source: Stanple: 80, 443, 5000-5010 Image: Name Set rule to the taken when a connection and Click Next. Image: Name Set rule to the taken when a connection matches the specified conditions? Image: Name	Specify the protocols and ports to	o which this rule applies.					
Protected and Protei <	Steps:						
Action Profile Name ↓ UDP Dees this rule apply to all local ports or specific local ports? ↓ All local ports Specific local ports: Soud Example: 80, 443, 5000-5010 ↓ Example: 8	Rule Type		DP?				
 Profile Name Does this rule apply to al local ports or specific local ports? Al local ports Specific local p		-					
Name Does this nule apply to al local ports or specific local ports? All local ports ③ Specific local ports Support Support Sector Allow the connection and click Next. Image: New Inbound Rule Wizard Action Portle Protes Action Protes Name Mate action should be taken when a connection matches the specified conditions? Mate action should be taken when a connection matches the specified conditions? Mate action should be taken when a connection matches the specified conditions? Mate action should be taken when a connection matches the specified conditions? Mate action should be taken when a connection matches the specified conditions? Mate action should be taken when a connection matches the specified conditions? Mate action should be taken when a connection matches the specified conditions? Mate action should be taken when a connection matches the specified conditions? Mate action should be taken when a connection matches the specified conditions? Material Action Display the action should be taken when a connection matches the specified conditions? Material Action Display the action should be taken when a connection matches the specified conditions? Material Action Display take action should be taken when a connection matches the specified conditions? Material Action Display take action should be taken when		O UDP					
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Example: 80, 443, 5000-5010 Example: 80, 443, 5000-5010 Image: I		○ All local ports					
✓ Back Next > Cancel Select Allow the connection and click Next.		Specific local ports:	5000				
Select Allow the connection and click Next. Action Steps: Protocol and Pots Action Profile Name Mule Type Profice Name Cutomiceus Cutomiceus			Example: 80,	, 443, 5000-5010			
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	 New Inbound Rule Wizar Action Specify the action to be taken with Steps: Rule Type Protocol and Ports Action Profile 	rd hen a connection matches the conditions s What action should be taken wf Allow the connection This includes connection if This includes only connection will be secured using the set	nen a connection i at are protected w it is secure ns that have been	matches the speci vith IPsec as well a n authenticated by	fied conditions? Is those are not. using IPsec. Cor	nections security	
O Block the connection	 New Inbound Rule Wizar Action Specify the action to be taken with Steps: Rule Type Protocol and Ports Action Profile 	rd what action should be taken wh action should be action at the connection if in this includes only connection will be secured using the sett Rule node.	nen a connection i at are protected w it is secure ns that have been	matches the speci vith IPsec as well a n authenticated by	fied conditions? Is those are not. using IPsec. Cor	inections Security	
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	New Inbound Rule Wizar Action Specify the action to be taken with Steps: Rule Type Protocol and Ports Action Profile	rd hen a connection matches the conditions s What action should be taken wi a Allow the connection This includes connections th Allow the connection if i This includes only connection will be secured using the sett Rule node. Customize	nen a connection i at are protected w it is secure ns that have been	matches the speci vith IPsec as well a n authenticated by	fied conditions? Is those are not. using IPsec. Cor	nections Security	
	New Inbound Rule Wizar Action Specify the action to be taken with Steps: Rule Type Protocol and Ports Action Profile	rd hen a connection matches the conditions s What action should be taken wi a Allow the connection This includes connections th Allow the connection if i This includes only connection will be secured using the sett Rule node. Customize	nen a connection i at are protected w it is secure ns that have been	matches the speci vith IPsec as well a n authenticated by	fied conditions? Is those are not. using IPsec. Cor	nections iecurity	
	New Inbound Rule Wizar Action Specify the action to be taken with Steps: Rule Type Protocol and Ports Action Profile	rd hen a connection matches the conditions s What action should be taken wi a Allow the connection This includes connections th Allow the connection if i This includes only connection will be secured using the sett Rule node. Customize	nen a connection i at are protected w it is secure ns that have been	matches the speci vith IPsec as well a n authenticated by	fied conditions? Is those are not. using IPsec. Cor	nections iecurity	
	New Inbound Rule Wizar Action Specify the action to be taken with Steps: Rule Type Protocol and Ports Action Profile	rd hen a connection matches the conditions s What action should be taken wi a Allow the connection This includes connections th Allow the connection if i This includes only connection will be secured using the sett Rule node. Customize	nen a connection i at are protected w it is secure ns that have been	matches the speci vith IPsec as well a n authenticated by	fied conditions? Is those are not. using IPsec. Cor	nections iecurity	
	New Inbound Rule Wizar Action Specify the action to be taken with Steps: Rule Type Protocol and Ports Action Profile	rd hen a connection matches the conditions s What action should be taken wi a Allow the connection This includes connections th Allow the connection if i This includes only connection will be secured using the sett Rule node. Customize	nen a connection i at are protected w it is secure ns that have been	matches the speci vith IPsec as well a n authenticated by	fied conditions? Is those are not. using IPsec. Cor	nections iecurity	
	New Inbound Rule Wizar Action Specify the action to be taken with Steps: Rule Type Protocol and Ports Action Profile	rd hen a connection matches the conditions s What action should be taken wi a Allow the connection This includes connections th Allow the connection if i This includes only connection will be secured using the sett Rule node. Customize	nen a connection i at are protected w it is secure ns that have been	matches the speci vith IPsec as well a n authenticated by	fied conditions? Is those are not. using IPsec. Cor	nections iecurity	
	New Inbound Rule Wizar Action Specify the action to be taken wi Steps: Rule Type Protocol and Ports Action Profile	rd hen a connection matches the conditions s What action should be taken wi a Allow the connection This includes connections th Allow the connection if i This includes only connection will be secured using the sett Rule node. Customize	nen a connection i at are protected w it is secure ns that have been	matches the speci vith IPsec as well a n authenticated by	fied conditions? Is those are not. using IPsec. Cor	nections Security	

d. Select Domain, Private, Public checkbox and click Next.

Action Profile Name Profile Name Private Applies when a computer is connected to a private network location, such as a home or work place. Public Applies when a computer is connected to a public network location. Public Applies when a computer is connected to a public network location.		Cancel
Picke Type Protocol and Pots Action Profile Name		Cancel
Profile Applies when a computer is connected to its corporate domain. Private Applies when a computer is connected to a private network location, such as a home or work place. Public Public Applies when a computer is connected to a public network location. ✓ Public Applies when a computer is connected to a public network location. Cancel There is connected to a public network location. Cancel Next > Cancel There is connected to a public network location. Profile Applies when a computer is connected to a public network location. Cancel There is connected to a public network location. Profile Next > Cancel There Name, Description (optional), and click Finish. Cancel Profile Next Isocation of this rule. Step: Profile Profile Name Name Name		Cancel
Profile Applies when a computer is connected to its corporate domain. Private Applies when a computer is connected to a private network location, such as a home or work place. Public Public Applies when a computer is connected to a public network location. ✓ Public Applies when a computer is connected to a public network location. Cancel There is connected to a public network location. Cancel Next > Cancel There is connected to a public network location. Profile Applies when a computer is connected to a public network location. Cancel There is connected to a public network location. Profile Next > Cancel There Name, Description (optional), and click Finish. Cancel Profile Next Isocation of this rule. Step: Profile Profile Name Name Name		Cancel
Name Private Applies when a computer is connected to a private network location, such as a home or work place. Public Applies when a computer is connected to a public network location. Public Applies when a computer is connected to a public network location. Cancel Enter Name, Description (optional), and click Finish. Neme Neme Specify the name and description of this rule. Specify the name and description of this rule. Step: Public Name Protocol and Ports Action Profile Name		Cancel
Public Applies when a computer is connected to a public network location. Applies when a computer is connected to a public network location. Image: Connected to a public network location. Applies when a computer is connected to a public network location. Image: Connected to a public network location. <t< td=""><td></td><td>Cancel</td></t<>		Cancel
Image: Specify the name and description of this rule. Steps: ● Rule Type ● Protocol and Ports ● Action ● Profile ● Name		Cancel
Enter Name, Description (optional), and click Finish.	Next > (Cancel
Name Specify the name and description of this rule. Steps: • Rule Type • Protocol and Ports • Action • Profile • Name		
New Inbound Rule Wizard Name Steps: • Rule Type • Protocol and Pots • Action • Profile • Name		
Name Specify the name and description of this rule. Steps: • Rule Type • Protocol and Ports • Action • Profile • Name • TekExpress		
Specify the name and description of this rule. Steps: Rule Type Protocol and Pots Action Profile Name: TekExpress		
Steps: Rule Type Protocol and Ports Action Profile Name TekExpress		
Rule Type Protocol and Ports Action Profile Name: TekExpress		
Protocol and Ports Action Profile Name: TekExpress		
Action Profile Name: TekExpress		
Profile Name: TekExpress		
Name TekExpress		
a Name		_
Description (optional):		

4. Check whether the Rule name is displayed in Windows Firewall with Advanced Security menu > Inbound Rules.

Windows Defender Firewall with ile Action View Help	Advanced Security					_	
ile Action View Help							
Windows Defender Firewall with	Inbound Rules					Actions	
K Inbound Rules	Name	Group	Profile	Enabled	Action ^	Inbound Rules	
Cutbound Rules	TechSmith Snagit		All	Yes	Allow	Rew Rule	
Connection Security Rules	V TekExpress		All	Yes	Allow		
Nonitoring	TekExpress Application Port (In)		All	Yes	Allow	Filter by Profile	
	TekExpress Automotive PAM3 Analysis(In)		All	Yes	Allow	Filter by State	
	TekExpress D-PHY(In)		All	Yes	Allow	Filter by Group	
	TekExpress M-PHY Tx(In)		All	Yes	Allow	View	
	V TekVISA RM software		All	Yes	Allow		
	IrendUpdateAgent		Private	Yes	Allow	Refresh	
	C TrendUpdateAgent		Private	Yes	Allow	🗟 Export List	
	VNC_TCP_5800		Domain	Yes	Allow	Help	
	VNC_TCP_5900		Domain	Yes	Allow		
	VPN_UDP_62515		Private,	Yes	Allow		
	VPN_UDP_62515		Domain	Yes	Allow		
	@{Microsoft.AAD.BrokerPlugin_1000.16299	@{Microsoft.AAD.BrokerPlugi	Domai	Yes	Allow		
	@{Microsoft.DesktopAppInstaller_1.0.2092	@{Microsoft.DesktopAppInst	Domai	Yes	Allow		
	@{Microsoft.Messaging_4.1810.2922.0_x64	@{Microsoft.Messaging_4.18	All	Yes	Allow		
	@{Microsoft.MicrosoftEdge_41.16299.492	@{Microsoft.MicrosoftEdge	Domai	Yes	Allow		
	@{Microsoft.OneConnect_3.1811.3082.0_x6	@{Microsoft.OneConnect_3.1	Domai	Yes	Allow		
	@{Microsoft.Windows.CloudExperienceHo	@{Microsoft.Windows.Cloud	Domai	Yes	Allow		
	@{Microsoft.Windows.CloudExperienceHo	@{Microsoft.Windows.Cloud	Domai	Yes	Allow		
	@{Microsoft.Windows.CloudExperienceHo	@{Microsoft.Windows.Cloud	Domai	Yes	Allow		
	🔮 @{Microsoft.Windows.Cortana_1.9.6.16299	@{Microsoft.Windows.Corta	Domai	Yes	Allow		
	🔮 @{Microsoft.Windows.Photos_2018.18091	@{Microsoft.Windows.Photo	All	Yes	Allow		
	@{Microsoft.Windows.Photos_2019.19081	@{Microsoft.Windows.Photo	All	Yes	Allow		
	@{Microsoft.WindowsFeedbackHub_1.180	@{Microsoft.WindowsFeedb	Domai	Yes	Allow		
	@ (Microsoft.WindowsStore_11810.1001.12	@{Microsoft.WindowsStore	AII	Yes	Allow 🗸		

TekVISA configuration

1. Click Start > All Programs > TekVISA > OpenChoice Instrument Manager.

📅 OpenChoice Instrument N	lanager				\times
File Edit Help					
Instruments < Last Updated: 9/11/202	▶ 0 2:42 AM	A	Applications and Utilitie OpenChoice Call Mo OpenChoice Talker	nitor	
Instrument List Update Search Criteria	Instrument Identify Properties.		Start Application or	Utility Tektro i	nix

2. Click Search Criteria. In Search Criteria menu, click LAN to Turn-on. Select Socket from the drop-down list, enter the IP address of

the TekExpress device in Hostname and type Port as 5000. Click

to configure the IP address with Port.

Enter the Hostname as 127.0.0.1 if the TekVISA and TekExpress application are in the same system, else enter the IP address of the oscilloscope where the TekExpress application is running.

VISA W	Search Criteria	
	GPIB	On On
	LAN	On 🖸
	Search LAN	
	Auto Discovery	Parameters
	Hostname	
	Socket -	4000
)
	Socket 127.0.0.1 5000 Socket 134.64.244.227 50	00
	Delete	Search
	Serial	Off
	VXI	On On
	USB	Off
	TekLink	Off
	Done	Help

3. Click Search to setup the TCPIP connection with the host. Check whether the TCPIP host name is displayed in OpenChoice Instrument Manager > Instruments.

🖼 OpenChoice Instrument Manager		🖼 Search Criteria 📃 📼 🔜
File Edit Help		GPIB O on
Instruments	Applications and Utilities	LAN O on
IGFB GPIB: 1-INSTR	OpenChoice Call Monitor OpenChoice Talker Liste	Search LAN Parameters Auto Discovery Hostname Port Socket 127.0.0.1 5000 Socket 124.64.224 227 5000 Delete Search
Last Updated: 9/11/2020 2:55 AM		
Instrument List Update Search Criteria.	Start Application or Utility	Serial O off VXI O on USB O off
	Tektronix	TekLink O off Done Help

4. Double-click **OpenChoice Talker Listener** and enter the Command *IDN? in command entry field and click **Query**. Check that the Operation is successful and Talker Listener Readout displays the Command / Data.

Instruments GPIB GPIB8::1::INSTR Sould TOPIP::127.0.0.1::5000::SOCKE	Enter Command or Script "IDN? Write Read Query Hex Entry Enabled Command / Script History
Last Updated 9/11/2020 3:02 AM Update Reset Communications	AutoQuery - False ; Term Char - LF ;
Talker Listener Readout:	Display As: 💿 ASCII Only 💿 Hex and ASCII
	ee eenning enning eenning i jee

Set or query the device name of application

This command sets or queries the device name of the application.

Syntax

```
TEKEXP:SELECT DEVICE, "<DeviceName>" (Set)
```

TEKEXP:SELECT? DEVICE (Query)

Command arguments

Argument Name	Argument Type
<devicename></devicename>	<string></string>
• QSFP+ Tx	NA
• SFP+ Tx	

Returns

<String>

Examples

TEKEXP:SELECT DEVICE, "<DeviceName>" command sets the device name of the application.

TEKEXP: SELECT? DEVICE command returns the selected device name of the application.

Set or query the suite name of the application

This command sets or queries the suite name of the application.

Syntax

TEKEXP:SELECT SUITE, "<SuiteName>" (Set)

TEKEXP:SELECT? SUITE (Query)

Command arguments

Argument Name	Argument Type and value	Description
<suitename></suitename>	a	It is the name of the suite on the DUT panel
• Host	NA	of the application.
• Module		

Returns

<String>

Examples

TEKEXP:SELECT SUITE, "<SuiteName>" command sets the suite name of the application.

TEKEXP:SELECT? SUITE command returns the selected suite of the application.

Set or query the test name of the application

This command selects or deselects the specified test name of the application.

Syntax

```
TEKEXP:SELECT TEST, "<TestName>", <Value> (Set)
TEKEXP:SELECT TEST, "<ALL>" (Set)
TEKEXP:SELECT? TEST (Query)
```

Command arguments

Test Name	Value
Host • Single Ended Output Voltage Range • Output AC Common Mode voltage (RMS) • Crosstalk Source Rise/Fall Time (20%-80%) • Crosstalk Source Amplitude (p-p Differential) • Signal Rise/Fall Time (20%-80%) • Total Jitter • Total Jitter @ J2 (Informative) • Total Jitter @ J9 (Informative) • Data Dependent Jitter • Data Dependent Pulse Width Shrinkage • Uncorrelated Jitter • Transmitter Qsq • Eye Mask Hit Ratio • Voltage Modulation Amplitude (p-p) • Transmitter Qsq (for Cu) • Output AC Common Mode voltage (RMS) (for Cu) • Host Output TWDPc	{True False} or {1 0} It represents selected or unselected. Where, True or 1 - Selected False or 0 - Unselected
Module • Single Ended Input Voltage Tolerance • AC Common Mode Voltage Tolerance • Crosstalk Source Rise/Fall Time (20%-80%) • Crosstalk Source Amplitude (p-p Differential) • Total Jitter • Total Jitter @ J2 (Informative) • Total Jitter @ J9 (Informative) • Data Dependent Jitter • Data Dependent Pulse Width Shrinkage • Uncorrelated Jitter • Eye Mask Hit Ratio • Output AC Common Mode voltage (RMS)	{True False} or {1 0} It represents selected or unselected. Where, True or 1 - Selected False or 0 - Unselected

Returns

{True | False} or {1 | 0}

Examples

TEKEXP:SELECT TEST, "<TestName>", 1 command selects the specified test in the Test Panel.

TEKEXP:SELECT TEST, "<ALL>" command select all the tests in the Test Panel.

TEKEXP:SELECT? TEST command returns the list of selected tests.

Set or query the version name of the application

This command sets or queries the version name of the application.

Syntax

TEKEXP:SELECT VERSION, "<VersionName>" (Set)

TEKEXP: SELECT? VERSION (Query)

Command arguments

Argument Name	Argument Type	Valid Values
<versionname></versionname>	5	It is the name of the version on the DUT
SFF-8635 Revision 0.4	• NA	panel of the application.

Returns

<String>

Examples

TEKEXP:SELECT VERSION, "<VersionName>" command sets the version name of application.

TEKEXP:SELECT? VERSION command returns the version name of application.

Set or query the general parameter values

This command sets or queries the general parameter values of the application.

Syntax

TEKEXP:VALUE GENERAL, "<ParameterName>", "<Value>" (Set)

TEKEXP:VALUE? GENERAL, "<ParameterName>" (Query)

Command arguments

Table 17: Command arguments for general settings

Parameter Name	Value
Direct Attached Cable Cu	EnabledDisabled
Device Type	 QSFP+ Tx SFP+ Tx
Suite Type	HostModule

lable continued...

Parameter Name	Value	
Record Length	• 9.95328	
	• 10.3125	
	• 10.51875	
	• 11.10	
Apply Filter	• Yes	
	• No	
Filter File Path (.flt file)	Filter path (User filter file path)	
Apply Filter for TWDPc	• Yes	
	• No	
Filter File Path for TWDPc (.flt file)	Filter path (User filter file path)	

Returns

<NRf> or <String>

Examples

TEKEXP:VALUE GENERAL, "<ParameterName>", "<Value>" command set the value for the specified general parameter.

TEKEXP:VALUE? GENERAL, "<ParameterName>" command returns the value for the specified general parameter.

Set or query the acquire parameter values

This command sets or queries the acquire parameter values of the application.

Syntax

```
TEKEXP:VALUE
ACQUIRE,"<TestName>","<AcquireType>","<ParameterName>","<ParameterValue>" (Set)
```

TEKEXP:VALUE? ACQUIRE, "<TestName>", "<AcquireType>", "<ParameterName>" (Query)

Command arguments

Test Name	Acquire Type	Parameter Name	Parameter Values
Host			
Single Ended Output Voltage Range	Single Ended Output Voltage Range Acquisition	Signal Type	 Single Ended PRBS7 Single Ended PRBS9 Single Ended PRBS11 Single Ended PRBS15 Single Ended PRBS20 Single Ended PRBS23 Single Ended PRBS31
Output AC Common Mode voltage (RMS)	Output AC Common Mode voltage (RMS) Acquisition		 PRBS7 PRBS9 PRBS11 PRBS15 PRBS20 PRBS23 PRBS31
Crosstalk Source Rise/Fall Time (20%-80%)	Crosstalk Source Rise/Fall Time (20%-80%) Acquisition		 Crosstalk 8180 Crosstalk PRBS7 Crosstalk PRBS9 Crosstalk PRBS11 Crosstalk PRBS15 Crosstalk PRBS20 Crosstalk PRBS23 8180 PRBS7 PRBS9 PRBS15 PRBS15 PRBS20 PRBS23
Crosstalk Source Amplitude (p-p Differential)	Crosstalk Source Amplitude (p-p Differential) Acquisition		
Signal Rise/Fall Time (20%-80%)	Signal Rise/Fall Time (20%-80%) Acquisition		
Table continued	1		

Acquisition Total Jitter @ J9 (Informative) Total Jitter Acquisition Data Dependent Jitter Data Dependent	@ J2 (Informative) @ J9 (Informative)	Signal Type BER Signal Type	 PRBS31 PRBS7 PRBS9 PRBS11 PRBS15 PRBS20 PRBS23 PRBS31 Range(2-18) PRBS7 PRBS9 PRBS11
Total Jitter @ J2 (Informative)Total Jitter AcquisitionTotal Jitter @ J9 (Informative)Total Jitter AcquisitionTotal Dependent JitterData DependentData Dependent Pulse Width ShrinkageData Dependent	@ J2 (Informative) @ J9 (Informative)	BER	 PRBS9 PRBS11 PRBS15 PRBS20 PRBS23 PRBS31 Range(2-18) PRBS7 PRBS9 PRBS11
Total Jitter @ J9 (Informative) Total Jitter Acquisition Data Dependent Jitter Data Dependent Data Dependent Pulse Width Shrinkage Data Dependent	@ J9 (Informative)		PRBS7PRBS9PRBS11
Total Jitter @ J9 (Informative) Total Jitter Acquisition Data Dependent Jitter Data Dependent Data Dependent Pulse Width Shrinkage Data Dependent	@ J9 (Informative)	Signal Type	PRBS9 PRBS11
		1	PRBS15PRBS20
			PRBS23 PRBS31
	ndent Pulse Width Shrinkage		 PRBS7 PRBS9 PRBS11 PRBS15
Uncorrelated Jitter Uncorrelate	ed Jitter Acquisition		 PRBS7 PRBS9 PRBS11 PRBS15 PRBS20 PRBS23 PRBS31
Transmitter Qsq Transmitter	Qsq Acquisition		 8180 PRBS7 PRBS9 PRBS11 PRBS15 PRBS20 PRBS23 PRBS31
Eye Mask Hit Ratio Eye Mask H		1	PRBS7

Table continued...

Test Name	Acquire Type	Parameter Name	Parameter Values
			 PRBS9 PRBS11 PRBS15 PRBS20 PRBS23 PRBS31
Voltage Modulation Amplitude (p-p)	Voltage Modulation Amplitude (p-p) Acquisition		• 8180 • PRBS7
Transmitter Qsq (for Cu)	Transmitter Qsq (for Cu) Acquisition		 PRBS7 PRBS9 PRBS11 PRBS15 PRBS20 PRBS23 PRBS31
Output AC Common Mode voltage (RMS) (for Cu)	Output AC Common Mode voltage (RMS) (for Cu) Acquisition		 PRBS7 PRBS9 PRBS11 PRBS15 PRBS20 PRBS23 PRBS31
Host Output TWDPc	Host Output TWDPc Acquisition		

Test Type	Acquire Type	Parameter Name	Parameter Values
Module			
Single Ended Input Voltage Tolerance	Single Ended Input Voltage Tolerance Acquisition	Signal Type	 Single Ended PRBS7 Single Ended PRBS9 Single Ended PRBS11 Single Ended PRBS15 Single Ended PRBS20 Single Ended PRBS23 Single Ended PRBS31
AC Common Mode Voltage Tolerance	AC Common Mode Voltage Tolerance Acquisition		 PRBS7 PRBS9 PRBS11 PRBS15 PRBS20
Table continued	1	L	

Test Type	Acquire Type	Parameter Name	Parameter Values
			PRBS23PRBS31
Crosstalk Source Rise/Fall Time (20%-80%) Crosstalk Source Amplitude (p-p Differential)	Crosstalk Source Rise/Fall Time (20%-80%) Acquisition Crosstalk Source Amplitude (p-p Differential) Acquisition		 Crosstalk 8180 Crosstalk PRBS7 Crosstalk PRBS9 Crosstalk PRBS11 Crosstalk PRBS15 Crosstalk PRBS20 Crosstalk PRBS23
Total Jitter	Total Jitter Acquisition	Signal Type	 PRBS7 PRBS9 PRBS11 PRBS15 PRBS20 PRBS23 PRBS31
		BER	Range(2-18)
Total Jitter @ J2 (Informative) Total Jitter @ J9 (Informative)	Total Jitter @ J2 (Informative) Acquisition Total Jitter @ J9 (Informative) Acquisition	Signal Type	PRBS7PRBS9PRBS11
Data Dependent Jitter	Data Dependent Jitter Acquisition		 PRBS15 PRBS20 PRBS23 PRBS31
Data Dependent Pulse Width Shrinkage	Data Dependent Pulse Width Shrinkage Acquisition		 PRBS7 PRBS9 PRBS11 PRBS15
Uncorrelated Jitter	Uncorrelated Jitter Acquisition		PRBS7
Eye Mask Hit Ratio	Eye Mask Hit Ratio Acquisition		PRBS9
Output AC Common Mode voltage (RMS)	Output AC Common Mode voltage (RMS) Acquisition		 PRBS11 PRBS15 PRBS20 PRBS23 PRBS31

<Nrf>

Examples

TEKEXP:VALUE

```
ACQUIRE, "<TestName>", "<AcquireType>", "<ParameterName>", "<ParameterValue>" command sets the value for the specified test and its acquire parameter.
```

TEKEXP:VALUE? ACQUIRE, "<TestName>", "<AcquireType>", "<ParameterName>" command returns the value for the specified test and its acquire parameter.

Set or query the analyze parameter values

This command sets or queries the analyze parameter values of the application.

Syntax

```
TEKEXP:VALUE ANALYZE, "<TestName>", "<ParameterName>", "<ParameterValue>" (Set)
```

TEKEXP:VALUE? ANALYZE, "<TestName>", "<ParameterName>" (Query)

Command arguments

Test Name	Parameter Name	Values
Transmitter Qsq	Window Width (%)	• 5
Transmitter Qsq (for Cu)		• 10 • 20

Returns

<Nrf>

Examples

```
TEKEXP:VALUE ANALYZE, "<TestName>", "<ParameterName>", "<ParameterValue>" command set the value for the specified test and its analyze parameter.
```

TEKEXP:VALUE? ANALYZE, "<TestName>", "<ParameterName>" command returns the value for the specified test and its analyze parameter.

Query the available devices in the DUT panel of the application

Syntax

TEKEXP:LIST? DEVICE (Query)

Command arguments

Device	Device Type and value	Description
<device></device>	<string> • QSFP+ Tx • SFP+ Tx</string>	It is the name of the device on the DUT panel of the application.

<String>

Examples

TEKEXP:LIST? DEVICE command returns the list of available devices.

Query the available suites for the selected device

This command queries the list of available suites for the selected device as comma separated values.

Syntax

TEKEXP:LIST? SUITE (Query)

Command arguments

Device and Suite Type	Description
QSFP+ Tx	It is the name of the suites for the selected device.
• Host	
Module	
SFP+ Tx	
• Host	
• Module	

Returns

<String>

Examples

TEKEXP:LIST? SUITE command returns the list of available suites for the selected device.

Query the list of available tests of the application

This command queries the list of available tests of the application for the selected device as comma separated values.

Syntax

TEKEXP:LIST? TEST (Query)

Command arguments

Test Name	String
Host	 Single Ended Output Voltage Range Output AC Common Mode voltage (RMS) Crosstalk Source Rise/Fall Time (20%-80%) Crosstalk Source Amplitude (p-p Differential)
	Signal Rise/Fall Time (20%-80%)
	Total Jitter
Table continued	

Test Name	String
	Total Jitter @ J2 (Informative)
	Total Jitter @ J9 (Informative)
	Data Dependent Jitter
	Data Dependent Pulse Width Shrinkage
	Uncorrelated Jitter
	Transmitter Qsq
	Eye Mask Hit Ratio
	Voltage Modulation Amplitude (p-p)
	Transmitter Qsq (for Cu)
	Output AC Common Mode voltage (RMS) (for Cu)
	Host Output TWDPc
Module	Single Ended Input Voltage Tolerance
	AC Common Mode Voltage Tolerance
	Crosstalk Source Rise/Fall Time (20%-80%)
	Crosstalk Source Amplitude (p-p Differential)
	Total Jitter
	Total Jitter @ J2 (Informative)
	Total Jitter @ J9 (Informative)
	Data Dependent Jitter
	Data Dependent Pulse Width Shrinkage
	Uncorrelated Jitter
	Eye Mask Hit Ratio
	Output AC Common Mode voltage (RMS)

<String>

Examples

TEKEXP:LIST? TEST command returns the list of available tests for the selected device.

Query the available version names of the application

This command queries the list of available version names of the application for the selected device as comma separated values.

Syntax

TEKEXP:LIST? VERSION (Query)

Returns

<String>

Examples

TEKEXP:LIST? VERSION command returns the list of version names for the selected device.

Query the list of available instruments based on the specified instrument type

This command queries the list of available instruments based on the specified instrument type.

Syntax

TEKEXP:LIST? INSTRUMENT, "<InstrumentType>" (Query)

Command argument

Argument Name	Argument value
<instrumenttype></instrumenttype>	<string></string>

Returns

<String>

Examples

TEKEXP:LIST? INSTRUMENT, "Real Time Scope" command returns the list of available instruments based on the real time scope type.

Set or query the IP address of the instrument based on the specified instrument type

This command sets or queries the IP address of the instrument based on the specified instrument type.

Syntax

TEKEXP: INSTRUMENT? "<InstrumentType>" (Query)

TEKEXP:INSTRUMENT, "<InstrumentType>", "<Value>" (Set)

Command argument

Argument Name	Argument Type
<instrumenttype></instrumenttype>	<string></string>
<value></value>	<string></string>
	TCPIP::XXX.XX.XXX.XXX::INSTR

Returns

<String>

Examples

TEKEXP: INSTRUMENT? "<InstrumentType>" command returns the IP address of the oscilloscope.

TEKEXP: INSTRUMENT, "<InstrumentType>", "<value>" command sets the oscilloscope to the specified IP address.

Query the information of the generated report file

This command queries the information of the generated report file in the format "<FileSize>","<FileName>".

Pre-requisite

A session should be run earlier and the report should be generated to get the information of the report.

Syntax

TEKEXP: INFO? REPORT (Query)

Returns

<FileSize>:: <String> <FileName>:: <String>

Examples

TEKEXP: INFO? REPORT command returns the information of the generated report in the format ("1215", "DUT001.mht").

Query the information of the generated waveform files

This command queries the information of the generated waveform files in the format.

<File1Size,"File1Name">.

If there are more than one waveform, the waveform file names are displayed with the comma separated values in the format

<File1Size,"File1Name">,<File2Size,"File2Name">.

Syntax

TEKEXP: INFO? WFM (Query)

Returns

<FileSize>:: <String>

<FileName>:: <String>

Examples

TEKEXP: INFO? WFM command returns the information of the generated waveform in the format (20000858,"X:\SFP+ QSFP+\Untitled Session\DUT001\20200916_041609\Iter1_Short Record-length for SCOPE Period_NoSSC_DIFF.wfm").

Query the information of the generated image files

This command queries the information of the generated image files in the format.

<File1Size,"File1Name">.

If there are more than one image, the image file names are displayed with the comma separated values in the format

<File1Size,"File1Name">,<File2Size,"File2Name">.

Syntax

TEKEXP: INFO? IMAGE (Query)

Returns

<FileSize>:: <String>

<FileName>:: <String>

Examples

TEKEXP: INFO? IMAGE command returns the information of the generated image in the format (109058, "X:\SFP+ QSFP+ \Untitled Session\DUT001\20200916_041609\lter1_Short Record-length for SCOPE Period_NoSSC_DIFF.png";22794,"X:\SFP+ QSFP+ \UntitledSession\DUT001\20200916_041609\ScopePeriodPlot_Iteration1WithCursor.png").

Query the active TekExpress application name

This command queries the active TekExpress application name running on the oscilloscope.

Syntax

TEKEXP: *IDN? (Query)

Returns

<String>

Examples

TEKEXP: *IDN? command returns the active TekExpress application name running on the oscilloscope.

Set or query the DUTID of application

This command sets or queries the DUTID of the application.

Syntax

```
TEKEXP:VALUE DUTID, "<Value>" (Set)
```

TEKEXP:VALUE? DUTID (Query)

Command arguments

Argument Name	Argument Type
<value></value>	<string></string>

Returns

<String>

Examples

TEKEXP:VALUE DUTID, "DUT001" command sets the DUTID of the application to DUT001.

TEKEXP:VALUE? DUTID command returns the DUTID of the application.

Sets or query the acquire mode status

This command sets or queries the acquire mode status.

Syntax

```
TEKEXP:ACQUIRE MODE <Mode> (Set)
```

TEKEXP:ACQUIRE_MODE? (Query)

Command arguments

Argument Name	Argument value
<mode></mode>	LIVE PRE-RECORDED

Returns

LIVE | PRE-RECORDED

Examples

TEKEXP:ACQUIRE MODE LIVE command sets the acquire mode to the Live mode.

TEKEXP:ACQUIRE MODE? command returns the current acquire mode.

Set or query the execution mode status

This command sets or queries the execution mode status.

Syntax

TEKEXP:MODE <Mode> (Set)

TEKEXP:MODE? (Query)

Command arguments

Argument Name	Argument value
<mode></mode>	COMPLIANCE USER-DEFINED

Returns

COMPLIANCE | USER-DEFINED

Examples

TEKEXP:MODE COMPLIANCE command sets the execution mode to the compliance mode.

TEKEXP: MODE ? command returns the current execution mode.

Generate the report for the current session

This command generates the report for the current session.

Syntax

TEKEXP:REPORT GENERATE(Set)

Arguments

N/A

Examples

TEKEXP: REPORT GENERATE command generates the report for the current session.

Query the value of specified report header field in the report

This command queries the value of specified report header field in the report.

Syntax

```
TEKEXP:REPORT? "<Device Field>" (Query)
```

Command arguments

Argument Na	ame		
<device field<="" td=""><td><u> </u>></td><td></td><td></td></device>	<u> </u> >		
information se			ch field in the se
Setup Information DUT ID	DUT001	Probe1 Model	"1X"
	2020-10-22 11:24:39	Probel Serial Number	'N/A'
	TX-Device	Probe2 Model	"1X"
TekExpress AppEmulator Version	5.2.999.17 (DAILY)	Probe2 Serial Number	"N/A"
	5.2.999.17 INTERNAL	Probe3 Model	*1X*
	5.2.999.17_INTERNAL	Probes Model	
TekExpress Framework Version Spec Version	Spec 1.0	Probe3 Serial Number	'N/A'
TekExpress Framework Version Spec Version Overall Compliance Mode	Spec 1.0 Yes	Probe3 Serial Number Probe4 Model	*N/A* *1X*
TekExpress Framework Version Spec Version Overall Compliance Mode	Spec 1.0	Probe3 Serial Number Probe4 Model Probe4 Serial Number	"N/A" "1X" "N/A"
TekExpress Framework Version Spec Version Overall Compliance Mode	Spec 1.0 Yes	Probe3 Serial Number Probe4 Model Probe4 Serial Number Scope Model	"N/A" "1X" "N/A" DP05104
TekExpress Framework Version Spec Version Overall Compliance Mode	Spec 1.0 Yes	Probe3 Serial Number Probe4 Model Probe4 Serial Number Scope Model Scope Serial Number	"N/A" "1X" "N/A" DP05104 Not-Set
TekExpress Framework Version Spec Version Overall Compliance Mode	Spec 1.0 Yes	Probe3 Serial Number Probe4 Model Probe4 Serial Number Scope Model	"N/A" "1X" "N/A" DP05104

Returns

<String>

Examples

TEKEXP: REPORT? "DUT ID" command returns the value of DUT ID field in the report.

Query the value of specified result detail available in report summary/details table

This command queries the value of specified result detail available in report summary/details table.

Syntax

TEKEXP:RESULT? "<TestName>" (Query)
TEKEXP:RESULT? "<TestName>", "<ColumnName>" (Query)
TEKEXP:RESULT? "<TestName>", "<ColumnName>", <RowNumber> (Query)

Command arguments

Argument Name	Argument Type
<testname></testname>	<string></string>
It is the test name of which the details are required in the report.	
<columnname></columnname>	<string></string>
It is the column header name of which the details are required in the report.	
<rownumber></rownumber>	<string></string>
It is the row number of which the details are required in the report.	

<String>

Examples

TEKEXP:RESULT? "<TestName>" will return the pass fail status of test.

```
TEKEXP:RESULT? "<TestName>", "<ColumnName>" will return all the row values of specific column for the test with comma separated values.
```

```
TEKEXP:RESULT? "<TestName>", "<ColumnName>", <RowNumber> will return the column value of specified row number.
```

Restore the setup to default settings

This command restores the setup to default settings.

Syntax

TEKEXP:SETUP Default(Set)

Arguments

N/A

Examples

TEKEXP:SETUP Default command restores the setup to default settings.

Save the setup

This command saves the setup.

Syntax

TEKEXP:SETUP Save(Set)

Examples

TEKEXP:SETUP Save command saves the setup.

Save the settings to a specified session

This command saves the settings to a specified session.

Syntax

TEKEXP:SETUP Save, "<SessionName>"

Command arguments

Argument Name	Argument value
<sessionname></sessionname>	<string></string>

Examples

TEKEXP:SETUP Save, "<SessionName>" command saves the settings to a specified session.

Open the setup from a specified session

This command opens the setup from a specified session.

Syntax

TEKEXP:SETUP Open, "<SessionName>"(Set)

Command arguments

Argument Name	Argument value
<sessionname></sessionname>	<string></string>

Examples

TEKEXP:SETUP Open, "<SessionName>" command opens the setup from a specified session.

Query the current setup file name

This command queries the current setup file name.

Syntax

TEKEXP:SETUP? CURRENT (Query)

Returns

<String>

Examples

TEKEXP:SETUP? CURRENT command returns the current setup file name.

Run/stop/pause/resume the selected measurements execution in the application

This command run/stop/pause/resume the selected measurements execution in the application.

Syntax

```
TEKEXP:STATE <operation mode>(Set)
```

Command arguments

Argument Name	Argument value
<operation mode=""></operation>	• RUN
	• STOP
	• PAUSE
	• RESUME

Returns

RUN | STOP | PAUSE | RESUME

Examples

 ${\tt TEKEXP:STATE}$ ${\tt RUN}$ command runs the execution for the selected measurements.

Query the current measurement execution status

This command queries the current measurement execution status.

Syntax

TEKEXP:STATE? (Query)

Returns

RUNNING | PAUSED | WAIT | ERROR | READY

Examples

 ${\tt TEKEXP: STATE? } \textbf{ command returns the current measurement execution status.}$

Query whether the current setup is saved or not saved

This command queries whether the current setup is saved or not saved.

Syntax

TEKEXP:STATE? SETUP (Query)

Returns

Saved or Not-Saved

Examples

TEKEXP: STATE? SETUP command returns whether the current setup is saved or not saved.

Exit or close the application

The command exits or close the application

Syntax

TEKEXP:EXIT(Set)

Examples

TEKEXP: EXIT command close the application.

Query the status of the previous command execution

This command queries whether the previous command execution is completed successfully.

Syntax

TEKEXP: *OPC? (Query)

Returns

{0 | 1} or {True | False}

1 or True indicates that command execution is successful.

0 or False indicates that command execution is failed.

Examples

TEKEXP: *OPC? command returns whether the previous command operation is completed successfully.

Query the last error occurred

This command queries the last error occurred.

Syntax

TEKEXP:LASTERROR? (Query)

Returns

<String>

Examples

TEKEXP: LASTERROR? command returns the last error occurred.

Set or query the popup details

This command sets or queries the popup details.

Syntax

TEKEXP: POPUP? (Query)

TEKEXP: POPUP "<PopupResponse>" (Set)

Command arguments

Argument Name	Argument value
<popupresponse></popupresponse>	• Yes
	• No

Returns

The pop-up details return in the following format:

"<Tittle>","<message>","<response1>,<response2>".

Where,

<Tittle> :: <String>

<message> :: <String>

<response1>,<response2> :: <String>

Examples

TEKEXP: POPUP? command returns the popup details in following format ": "Do you really want to exit TekExpress?";Responses: "Yes, No".

TEKEXP: POPUP "Yes" command sets the popup response to Yes.

Sets or query the limit values in the limits editor window

This command sets or queries the limit values in the limits editor window.

Syntax

TEKEXP:VALUE LIMIT, <TestName>, <LimitHeader>, <Value1>, <CompareString>, <Value2>(Set)

TEKEXP:VALUE? LIMIT, <TestName>, <LimitHeader> (Query)

Returns

<String> or <NRf>

Examples

TEKEXP:VALUE LIMIT, <TestName>, <LimitHeader>, <Value1>, <CompareString>, <Value2> command sets the limits value for the specified testname and limit header.

TEKEXP:VALUE? LIMIT, <TestName>, <LimitHeader> command returns the limits value for the specified testname and limit header.

Set or query the waveform file recalled for the specified test name and acquire type

This command set or queries the waveform file recalled for the specified test name and acquire type.

If there are more than one waveform, the waveform file names are displayed with the symbol "\$" separated values in the format

<WaveformFileName1\$ WaveformFileName2>.

Syntax

```
TEKEXP:VALUE WFMFILE, <TestName>, <AcquireType>, <WaveformFileName> (Set)
```

TEKEXP:VALUE? WFMFILE, <TestName>, <AquireType> (Query)

Returns

<String>

Examples

TEKEXP:VALUE WFMFILE, <TestName>, <AquireType>, <WaveformFileName> command recalls the sepcified waveform file for the specified testname and acquire type.

TEKEXP:VALUE? WFMFILE, <TestName>, <AquireType> command returns the waveform file name recalled for the specified testname and acquire type.

Set or query the enable/disable status of Verbose function

This command sets or queries the enable/disable status of Verbose function.

Syntax

```
TEKEXP:VALUE VERBOSE, "<Value>" (Set)
```

TEKEXP: VALUE? VERBOSE (Query)

Arguments

Argument Name	Argument value
<value></value>	{True False} or {1 0}
	It represents enabled or disabled.
	Where,
	True or 1 - enabled
	False or 0 - disabled

Returns

{True | False} or {0 | 1}

Examples

TEKEXP:VALUE VERBOSE, "<Value>" command enable or disable the Verbose function.

TEKEXP:VALUE? VERBOSE command returns the enable or disable status of Verbose function.

Query the enable or disable status of Continuous run function.

This command queries the enable or disable status of Continuous run function.

Syntax

```
TEKEXP:VALUE? GENERAL, "Enable Continuous Run" (Query)
```

Returns

```
{True | False} or {0 | 1}
```

Where,

1 or True indicates that the continuous run function is enabled.

0 or False indicates that the continuous run function is disabled.

Examples

```
TEKEXP:VALUE? GENERAL, "Enable Continuous Run" command returns the enable or disable status of continuous run function.
```

Set or query the enable/disable status of Continuous Run function

This command sets or queries the enable/disable status of Continuous Run function.

Syntax

```
TEKEXP:VALUE ContinuousRun, "<Value>" (Set)
```

TEKEXP:VALUE? ContinuousRun (Query)

Arguments

Argument Name	Argument value
<value></value>	{True False} or {1 0}
	It represents enabled or disabled.
	Where,
	True or 1 - enabled
	False or 0 - disabled

Returns

{True | False} or {0 | 1}

Examples

TEKEXP:VALUE? ContinuousRun command returns the enable or disable status of Continuous run function.

TEKEXP:VALUE ContinuousRun, "<Value>" command enable or disable the Continuous run function.

Set or query the continuous run duration time value

This command sets or queries the continuous run duration time value.

Syntax

```
TEKEXP:VALUE? ContinuousRun Duration (Query)
```

TEKEXP:VALUE ContinuousRun Duration, "<Value>" (Set)

Arguments

Argument Name	Argument value
<value></value>	Infinite hh:mm
	Infinite sets the radio on button to infinite.
	hh:mm sets the continuous run duration to the specified time in hours and minutes. The minimum time duration you can set is 00:30.

Returns

Infinite | hh:mm

Examples

TEKEXP:VALUE? ContinuousRun_Duration command returns the continuous run duration time value.

```
TEKEXP:VALUE ContinuousRun Duration, "<Value>" command sets the continuous run duration time value.
```

Set or query the session create option in the continuous run function

This command sets or queries the option for session creation in the continuous run function.

Syntax

TEKEXP:VALUE? ContinuousRun_RunSessionOptions (Query)

TEKEXP:VALUE ContinuousRun_RunSessionOptions, "Value" (Set)

Arguments

Argument Name	Argument value
<value></value>	NewSession SameSession_ClearResults
	NewSession - creates new session for each run.
	SameSession_ClearResults - Clears the test results of the current session and starts the test execution. The session results will be added in the same session, by erasing the previous run results.

Returns

NewSession | SameSession_ClearResults

Examples

TEKEXP:VALUE? ContinuousRun_RunSessionOptions command returns the option for session creation in the continuous run function.

TEKEXP:VALUE ContinuousRun_RunSessionOptions, "Value" command sets the option for session creation in the continuous run function.

Set or query the View report after generating option status

This command sets or queries the enable/disable status of the View report after generating function.

Syntax

TEKEXP:VALUE? GENERAL, "View Report After Generating" (Query)

TEKEXP:VALUE GENERAL, "View Report After Generating", <value> (Set)

Arguments

Argument Name	Argument value
<value></value>	{True False} or {1 0}
	It represents enabled or disabled.
	Where,
	True or 1 - enabled
	False or 0 - disabled

Returns

{True | False} or {0 | 1}

Examples

TEKEXP:VALUE? GENERAL, "View Report After Generating" command returns the enable or disable status of view report after generating option.

TEKEXP:VALUE GENERAL, "View Report After Generating", <value> command enable or disable the view report after generating option.

Returns the report as XML string

This command returns the report as XML string.

Syntax

TEKEXP: REPORTASXML? (Query)

Returns

<String>

Examples

TEKEXP: REPORTASXML? command returns the report XML string.

Copies all the images from current run session to the given destination location

This command copies all the images from current run session to the given destination location.

Syntax

TEKEXP:COPYIMAGES <DestinationPath>(Set)

Command argument

<DestinationPath> :: <String>

Returns

NA

Examples

TEKEXP:COPYIMAGES C:\Temp command copies all the images from current run session to the mentioned location.

Selects the specified test(s) and deselect all other tests

This command selects the specified test(s) and deselect all other tests.

Syntax

```
TEKEXP:SELECTID <"TestID">(Set)
```

Command argument

Argument Name	Argument value
TestID	String

Returns

NA

Examples

TEKEXP: SELECTID "11101" This command select the test associated with the ID and deselects all other tests in the application.

TEKEXP: SELECTID "11101, 11102" This command selects the tests associated with the IDs and other tests will be deselected.

Returns the complete information about the selected test

This command returns the complete information about the selected test.

The information includes application name, TestID, Device selected, Suite selected, version, Test name, Test description.

Syntax

TEKEXP: TESTINFO? (Query)

Returns

<String>

Examples

TEKEXP: TESTINFO? This command returns the following details:

```
<TekExpress> <Test Id="11101" Device="TX-Device" Suite="Group1" Version="Spec 1.0" Name="Algorithm Library Measurement" Description="This is Algorithm Library measurement test. Refer Section-B of TekExpress SampleApp Development Guide for more details.
```

Set the default session

Sets the application configurations to default value.

Syntax

```
TEKEXP:SESSION DEFAULT (set)
```

Examples

```
TEKEXP:SESSION DEFAULT, sets the application configurations to default value.
```

Save the run/config sessions

Enter the name to save/config the session.

Syntax

```
TEKEXP:SESSION SAVE, "Session Name" (set)
```

Command arguments

Argument Name	Argument value
<session name=""></session>	<string></string>

Examples

TEKEXP:SESSION SAVE, "Session Name" saves the session.

Load the run/config session

Load the selected config/run session.

Syntax

TEKEXP:SESSION LOAD, "Session Name" (set)

Command arguments

Argument Name	Argument value
<session name=""></session>	<string></string>

Examples

TEKEXP:SESSION LOAD, "Session Name", load the selected config/run session.

Delete the run/config session

Deletes the selected config/run session.

Syntax

TEKEXP:SESSION DELETE, "Session1, Session2" (set)

Command arguments

Argument Name	Argument value
<session name=""></session>	<string></string>

Examples

TEKEXP:SESSION DELETE, "Session1, Session2", deletes the selected config/run session.

Run the run/config saved session

Run the selected config/run session.

Syntax

TEKEXP:SESSION RUN, "Session Name's separated by comma" (set)

Command arguments

Argument Name	Argument value
<session name=""></session>	<string></string>
Session Name's separated by comma (to run the multiple run sessions)	<string></string>

Examples

TEKEXP:SESSION RUN, "Session Name's separated by comma", runs the selected config/run session.

Query the available list in the run/config session

Returns the list of available config/run session.

Syntax

TEKEXP:SESSION? LIST

Returns

Returns the list of available config/run session.

Examples

TEKEXP:SESSION? LIST, returns the list of available config/run session.

Query the current run/config session

Returns the selected config/run session.

Syntax

TEKEXP:SESSION? CURRENT

Returns

Returns the selected config/run session.

Examples

TEKEXP:SESSION? CURRENT, returns the selected config/run session.

Override the run/config session

Overrides the selected config/run session.

Syntax

TEKEXP:SESSION SAVE, "SessionName", "True" (set)

Command arguments

Argument Name	Argument Type	Argument Value
<session name=""></session>	<string></string>	{True False} or {1 0}
		It represents enabled or disabled.
		Where,
		True or 1 - enabled
		False or 0 - disabled

Returns

{True | False} or {0 | 1}

Examples

TEKEXP:SESSION SAVE, "SessionName", "True", overrides the selected config/run session.

SFP+ QSFP+ Tx tests

Testing procedures and examples

Signal types used by tests

The following tables list the signal types used by each measurement for the two profiles.

Host profile

Table 18: Host profile measurement signal types

Measurement	Compliance mode support	User-Defined mode support	
Single Ended Output Voltage Range	PRBS31	PRBS7, PRBS9, PRBS11, PRBS15, PRBS20, PRBS23, PRBS31	
Output AC Common-Mode voltage (RMS)			
Crosstalk Source Rise/Fall Time (20%-80%)	8180	PRBS7, PRBS9, PRBS11, PRBS15, PRBS20, PRBS23, PRBS31,	
Crosstalk Source Amplitude (p-p)		8180	
Signal Rise/Fall Time (20%-80%)			
Total Jitter	PRBS31	PRBS7, PRBS9, PRBS11, PRBS15, PRBS20, PRBS23, PRBS31	
Total Jitter @ J2			
Total Jitter @ J9			
Data Dependent Jitter	PRBS9	PRBS7, PRBS9, PRBS11, PRBS15, PRBS20, PRBS23, PRBS31	
Data Dependent Pulse Width Shrinkage (DDPWS)		PRBS7, PRBS9, PRBS11, PRBS15	
Uncorrelated Jitter		PRBS7, PRBS9, PRBS11, PRBS15, PRBS20, PRBS23, PRBS31	
Transmitter Qsq	8180	PRBS7, PRBS9, PRBS11, PRBS15, PRBS20, PRBS23, PRBS31, 8180	
Eye Mask Hit Ratio	PRBS31	PRBS7, PRBS9, PRBS11, PRBS15, PRBS20, PRBS23, PRBS31	
Voltage Modulation Amplitude (p-p)	8180	PRBS7, PRBS9, PRBS11, PRBS15, PRBS20, PRBS23, PRBS31,	
Transmitter Qsq (for Cu)	1	8180	
Output AC Common Mode voltage (RMS) (for Cu)	PRBS31	PRBS7, PRBS9, PRBS11, PRBS15, PRBS20, PRBS23, PRBS31	
Host Output TWDPc	PRBS9	PRBS9	

Module profile

Table 19: Module profile measurement signal types

Measurement	Compliance mode support	User-Defined mode support
AC Common Mode Voltage Tolerance	PRBS31	PRBS7, PRBS9, PRBS11, PRBS15, PRBS20, PRBS23, PRBS31
Single Ended Input Voltage Tolerance		
Table continued		

Measurement	Compliance mode support	User-Defined mode support
Crosstalk Source Rise/Fall Time (20%-80%)	8180	PRBS7, PRBS9, PRBS11, PRBS15, PRBS20, PRBS23, PRBS31,
Crosstalk Source Amplitude (p-p)]	8180
Output AC Common-Mode voltage (RMS)	PRBS31	PRBS7, PRBS9, PRBS11, PRBS15, PRBS20, PRBS23, PRBS31
Total Jitter		
Total Jitter @ J2		
Total Jitter @ J9	-	
Data Dependent Jitter	PRBS9	PRBS7, PRBS9, PRBS11, PRBS15, PRBS20, PRBS23, PRBS31
Data Dependent Pulse Width Shrinkage (DDPWS)		PRBS7, PRBS9, PRBS11, PRBS15
Uncorrelated Jitter	1	PRBS7, PRBS9, PRBS11, PRBS15, PRBS20, PRBS23, PRBS31
Eye Mask Hit Ratio	PRBS31	PRBS7, PRBS9, PRBS11, PRBS15, PRBS20, PRBS23, PRBS31

Oscilloscope setup

The following tables show the generalized oscilloscope setup parameters for all tests, except where noted.

Table 20: Horizontal setup

Mode	Sample Rate	Record Length	Acquisition Mode
Manual	100 GS/s	5M, 10M	100 GS/s

Table 21: Vertical setup

Channel 1		Channel 2			
Position Scale Offset		Position	Scale	Offset	
0	Vertical setup procedure	0		Vertical setup procedure	0

Signal validation procedure

Each measurement goes through signal validation, signal acquisition, and measurement steps. Before running any measurement, check the signal for validity. To do this, set up the oscilloscope to acquire the signal and then test the signal for its characteristics such as voltage level and/or frequency. Once the characteristics of the signal are correct, the signal is valid and ready for use in compliance measurements. The signal validation procedure is the same for both Host and Module Profile measurements.

SFP+ solution supports three types of signals: PRBS9, PRBS31, and 8180.



Note: PRBS20, PRBS23, PRBS31 pattern validation is not done. The signal is assumed to be PRBS20, PRBS23, or PRBS31 respectively.

Acquire the signal according to the SFF-8431 specification. The oscilloscope setup differs for each measurement. For all measurements, use the following guidelines to set up the oscilloscope. For the oscilloscope setup for individual tests, see the individual test topics.

After the signal is acquired, the measurement is conducted using either the base oscilloscope, DPOJET, or the TekExpress algorithm library.

Oscilloscope setup guidelines

The following describes the oscilloscope setup and signal validation measurement for PRBS7, PRBS9, PRBS11, PRBS15, and 8180 signals.

1. Connect the input signal to the appropriate channels. (The channels are those selected as data sources in the Acquisitions tab of the Setup panel.)

The vertical setup routine runs automatically to find the best fitting vertical scale.

Horizontal setup uses these parameters:

- Mode: Manual
- Sample Rate: 100 GS/s
- Record Length: 5M/10M
- Acquisition Mode: Sample
- 2. On the oscilloscope, set Math1 = (Ch1 Ch3).
- 3. Call the Signal Validation algorithm to verify the signal type.

The signal validation results are returned from the algorithm. If signal validation fails, display a signal validation message.

Host test: SFF-8431 table 11 tests

Single-ended output voltage range

Single-ended output voltage range is measured as the single-ended peak-to-peak output voltage for the positive and negative data channels on a single acquisition. This test is one of the SFF-8431 Table 11 Output Electrical Specifications at B tests.

Connect the equipment as shown in the diagram at Connection Setup for Host Tests: All other Host tests.

Signal validation

Signal validation for PRBS31 pattern signals is not done by the SFP+ QSFP+ Tx application. The software assumes that the PRBS31 pattern is valid.

Measurement procedure

Single-ended output voltage range is measured using base DPOJET.

• Use DPOJET measurement name: Ampl > Max and Ampl > Min for Dp and Dn

Limits

For each of Dp and Dn: Minimum = -0.3 V; Maximum = 4 V

Snapshot and cursor placement details

There will be two snapshots:

- A snapshot of Dp with cursors placed at maximum and minimum voltages of single-ended Pk-Pk measurement value of Dp. Cursor values can be derived using DPOJET: Ampl > Cycle Max and Ampl > Cycle Min for +ve and –ve peak, respectively for Dp.
- A snapshot of Dn with cursors placed at maximum and minimum voltages of single-ended Pk-PK measurement value of Dn. Cursor values can be derived using DPOJET: **Ampl > Cycle Max** and **Ampl > Cycle Min** for +ve and –ve peak, respectively for Dn.

Output AC Common-Mode voltage (RMS) (Host)

Output AC common-mode voltage is measured as the AC RMS voltage of the common mode ((DP+DN) ÷ 2) signal. This test is one of the SFF-8431 Table 11 Output Electrical Specifications at B tests.

Connect the equipment as shown in the diagram at Connection Setup for Host Tests: All other Host tests.

Signal validation

Signal validation for PRBS31 pattern signals is not done by the SFP+ QSFP+ Tx application. The software assumes that the PRBS31 pattern is valid.

Measurement procedure

Output AC common-mode voltage is measured using the base oscilloscope.

- 1. Math1 = (Dp + Dn) ÷ 2. Switch off channels connected to Dp and Dn.
- 2. Draw a histogram bounding box from the top left of the oscilloscope to the bottom right, and choose Histogram Vertical.
- 3. Select Math1 as the histogram source.
- 4. From the Measure menu, select Histogram Measurements > Standard Deviation.
- 5. Do a single step run and measure the mean value of the histogram standard deviation. This is the measurement result.

Limits

Maximum = 15 mV

Snapshot and cursor placement details

A snapshot where the histogram on math and the standard deviation value of the histogram is visible on the screen. The standard deviation value visible on the screen should be the value reported in the report. No cursors are required.

Host test: SFF-8431 table 12 tests

Crosstalk source Rise/Fall time (20% - 80%) (Host)

Crosstalk source rise/fall time is measured as the 20% – 80% (of VMA) Rise time and 80% – 20% (of VMA) Fall time of the differential Crosstalk Source introduced to the signal. This test is one of the SFF-8431 Table 12 Jitter and Eye Mask Specifications at B tests.

Connect the equipment as shown in the diagram at Connection Setup for Host Tests: Table 12 Crosstalk Source Tests.

Signal validation

For compliance, perform Signal Validation Procedure.

Measurement procedure

The crosstalk source rise/fall time measurement is performed using the algorithm library.

Inputs to algorithm

- · Differential waveform obtained on a Math channel using Dp and Dn after deskewing and applying 12 GHz filter
- Signal Type ("SFPPlus.SignalType")

Algorithm

- Input the differential waveform.
- Obtain values of vHigh and vLow as done in the VMA measurement (averaged over all the patterns found in the waveform).
- · Find the position of the rising and falling edges in the input waveform.
- On each rising edge, traverse forward until the first point crossing the upper limit (80%) is found (= End) and traverse backward until the first point crossing the lower limit (20%) is found (= Start).
- On each falling edge, traverse backward until the first point crossing the upper limit (80%) is found (= Start) and traverse forward until the first point crossing the lower limit (20%) is found (= End).

- Transition time is computed as TT = (End Start). This value is averaged across all edges.
- End

Target value = 34 ps

Snapshot and cursor placement details

This measurement has two snapshots: the first with cursors placed at the rise time, the second with cursors placed at the fall time.

- Rise time: Zoom to the cursor positions. Cursor1 = starting point of RT of first rising edge, cursor2 = ending point of RT of first rising edge.
- Fall time: Zoom to the cursor positions. Cursor1 = starting point of FT of first falling edge, cursor2 = ending point of FT of first falling edge

Crosstalk source amplitude (p-p differential) (Host)

Crosstalk source amplitude is measured as the difference between the nominal one and zero levels, which are defined as voltages measured in the mid 20% of the high (eight 1s) and low (eight 0s) regions respectively, of the differential crosstalk source introduced to the signal. This test is one of the SFF-8431 Table 12 Jitter and Eye Mask Specifications at B tests.

Connect the equipment as shown in the diagram at Connection Setup for Host Tests: Table 12 Crosstalk Source Tests.

Signal validation

For compliance, perform Signal Validation Procedure.

Measurement procedure

The crosstalk source amplitude (p-p differential) measurement is performed using the algorithm library.

Inputs to algorithm

Differential waveform obtained on a Math channel using Dp and Dn after deskewing and applying 12 GHz filter

Algorithm

- · Input the differential waveform.
- On the input waveform, identify the regions with the pattern 11111111 or 00000000.
- On each such pattern, measure the mean voltage in the middle 20% of the pattern.
- The mean voltages corresponding to the Signal High regions is taken as vHigh, and the mean voltages corresponding to the Signal Low is taken as vLow. The vHigh and vLow values are averaged across all regions.
- The required result Amplitude is given by, Amplitude = vHigh vLow.
- End

Limits

Target value = 1000 mV

Snapshot and cursor placement details

This measurement has one snapshot with cursor1 = +ve high of VMA, cursor2 = -ve high of VMA.

Signal Rise/Fall time (20% - 80%)

Signal rise/fall time is measured as the 20% – 80% (of VMA) Rise time and 80% – 20% (of VMA) Fall time of the input signal. This test is one of the SFF-8431 Table 12 Jitter and Eye Mask Specifications at B tests.

Connect the equipment as shown in the diagram at Connection Setup for Host Tests: All other Host tests.

Signal validation

For compliance, perform Signal Validation Procedure.

Measurement procedure

The signal rise/fall time (20% – 80%) measurement is performed using the algorithm library.

Inputs to algorithm

- · Differential waveform obtained on a Math channel using Dp and Dn after deskewing and applying 12 GHz filter
- Signal Type ("SFPPlus.SignalType")

Algorithm

- Obtain values of vHigh and vLow as done in the "VMA" measurement. (Averaged over all the patterns found in the waveform.)
- · Find the position of rising and falling edges in the input waveform.
- On each rising edge, traverse forward until the first point crossing the upper limit (80%) is found (=End) and traverse backward until the first point crossing the lower limit (20%) is found (= Start).
- On each falling edge, traverse backward until the first point crossing the upper limit (80%) is found (=Start) and traverse forward until the first point crossing the lower limit (20%) is found (=End).
- Compute Transition Time, TT = (End Start) This value is averaged across all edges.
- End

Limits

Minimum value = 34 ps

Snapshot and cursor placement details

This measurement has two snapshots: first with cursors placed at the rise time, second with cursors placed at the fall time.

- Rise time: Zoom to the cursor positions. Cursor1 = starting point of RT of first rising edge, cursor2 = ending point of RT of first rising edge.
- Fall time: Fall time: Zoom to the cursor positions. Cursor1 = starting point of FT of first falling edge, cursor2 = ending point of FT of first falling edge.

Total jitter (Host)

TJ, as used here, is the Level 1 definition for Total Jitter as described in the FC-MJSQ, where TJ is the crossing width, defined as the late time at which the BER is 10–12 minus the early time at which the BER is 10–12. This test is one of the SFF-8431 Table 12 Jitter and Eye Mask Specifications at B tests.

Connect the equipment as shown in the diagram at Connection Setup for Host Tests: All other Host tests.

Signal validation

Signal validation for PRBS31 pattern signals is not done by the SFP+ QSFP+ Tx application. The software assumes that the PRBS31 pattern is valid.

Measurement procedure

Total jitter is measured using base DPOJET.

- Deskew the Data+ and Data- inputs. Compute the differential signal on Math1 = Dp Dn.
- Use DPOJET TJ@BER measurement on the Math signal and Skew measurement on the single-ended input signals.

DPOJET settings

• Select Tab: Select Jitter > TJ@BER.

- Configure the source:
 - Click the arrow button in the Source(s) column and configure Source 1 = Math 1 (Dp Dn)
 - Select the Advanced check box and then set Reference Level % relative to Base Top as follows:

Setting	Rise	Fall
High	80%	80%
Mid	50%	50%
Low	20%	20%
Hysteresis	5%	

- Click Close.
- Configure Tab:
 - Edges: Signal Type = Data
 - Clock Recovery:
 - Method = PLL Custom BW
 - PLL Model = Type II
 - Damping = 700 m
 - Loop BW = 4 MHz
 - Click the Advanced Button:
 - Nominal Data Rate = ON. Bit Rate = 10.3125 Gb/s
 - Known Data Pattern = OFF
 - Click OK.
 - RjDj:

For PRBS9 signal:

- Pattern Type = Repeating
- Pattern Length = 511 UI
- BER 1E- = 12 (for J2 BER 1E- = 2.6; for J9 BER 1E- = 9.6)

For PRBS31 signal:

- Pattern Type = Arbitrary
- Window length = 10 UI
- Population = 100
- BER 1E- = 12 (for J2 BER 1E- = 2.6; for J9 BER 1E- = 9.6)
- Filters: No filters
- General: OFF
- Global:
 - Gating: OFF
 - Quality: **OFF**
 - Population: OFF
- Results Tab: In the Options menu, deselect Display Units Absolute.
- Click Single.

Limits

Maximum value = 0.28 UI

Snapshot and cursor placement details

No cursors are required because total jitter cannot be shown using cursors or snapshots. Instead, zoom a part of the waveform to see the type of waveform used for the measurement. Zoom the waveform between time 0 and (Horizontal scale \div 10⁴). If the record length is 2M, the number of points in the zoomed part will be 200.

Data dependent jitter (Host)

DDJ is the range (max – min) of the timing variations measured on the Differential Signal with a crossing level equal to the average value of the entire waveform being measured. The waveform is averaged sufficiently to remove the effects of random jitter and noise in the system. This test is one of the SFF-8431 Table 12 Jitter and Eye Mask Specifications at B tests.

Connect the equipment as shown in the diagram at Connection Setup for Host Tests: All other Host tests.

Signal validation

For compliance, perform Signal Validation Procedure.

Measurement procedure

Data dependent jitter is measured using base DPOJET.

- Deskew the Data+ and Data- inputs. Compute the differential signal on Math1 = Dp Dn
- Use DPOJET DDJ measurement on the Math signal and Skew measurement on the single ended input signals.

DPOJET settings

- Select Tab: select **Jitter**, click **DDJ**.
 - Source configuration:
 - Source = Math 1 (Dp Dn)
 - Select the Advanced check box and then set Reference Level % relative to Base Top as follows:

Setting	Rise	Fall
High	80%	80%
Mid	50%	50%
Low	20%	20%
Hysteresis	5%	

- Click Close
- Configure Tab:
 - Clock Recovery:
 - Method = PLL-Custom BW
 - PLL Model = Type II
 - Damping = 700 m
 - Loop BW = 4 Mhz
 - Click the Advanced Button:
 - Nominal Data Rate = ON. Bit Rate = 10.3125 Gb/s
 - Known Data Pattern = OFF
 - Click OK.
 - RjDj:

For PRBS9:

- Pattern Type = Repeating
- Pattern Length = 511 UI
- BER 1E– = **12**

For PRBS31:

- Pattern Type = Arbitrary
- Window length = 10 UI
- Population = 100
- BER 1E- = 12
- Filters: No filters
- General: OFF
- Global:
 - Gating: OFF
 - Quality: OFF
 - Population: OFF
- Results Tab: In the Options menu, deselect Display Units Absolute.
- Click Single.

Limits

Maximum value = 0.10 UI

Snapshot and cursor placement details

No cursors are required because data dependent jitter cannot be shown using cursors or snapshots. Instead, zoom a part of the waveform to see the type of waveform used for the measurement. Zoom the waveform between time 0 and (horizontal scale \div 10⁴). If the record length is 2M, the number of points in the zoomed part will be 200.

Data dependent pulse width shrinkage (Host)

DDPWS is measured as the difference between one symbol period and the minimum of all the differences between pairs of adjacent edges on the differential signal with a crossing level equal to the average value of the entire waveform being measured. The waveform is averaged sufficiently to remove the effects of random jitter and noise in the system. This test is one of the SFF-8431 Table 12 Jitter and Eye Mask Specifications at B tests.

Connect the equipment as shown in the diagram at Connection Setup for Host Tests: All other Host tests.

Signal validation

For compliance, perform Signal Validation Procedure.

Measurement procedure

The data dependent pulse width shrinkage measurement is performed using the algorithm library.

Inputs to algorithm

Differential waveform obtained on a Math channel using Data+ and Data- after deskewing.

Algorithm

- Input differential waveform.
- Estimate the UI of the waveform (UI = bit duration).
- Identify all the PRBS9 patterns found in the acquired signal.

- · Overlap all the PRBS9 patterns found in the acquisition to get a single averaged PRBS9 pattern.
- Identify the minimum width between adjacent edges of the averaged PRBS9 pattern. [= minimum UI]
- · Compute Data Dependent Pulse Width Shrinkage (DDPWS) as: DDPWS = Estimated UI minimum UI.

Maximum value = 0.055 UI

Snapshot and cursor placement details

This measurement has one zoomed snapshot with cursor1 and cursor2 marking the smallest UI.

Uncorrelated jitter (Host)

Uncorrelated jitter refers to the component of jitter in the transmitted signal that is not correlated to the transmitter data. The uncorrelated jitter (rms) is given by the RMS value of the standard deviations of the two distributions, namely standard deviation of jitter on rising edge and standard deviation of jitter on falling edge. This test is one of the SFF-8431 Table 12 Jitter and Eye Mask Specifications at B tests.

Connect the equipment as shown in the diagram at Connection Setup for Host Tests: All other Host tests.

Signal validation

For compliance, perform Signal Validation Procedure.

Measurement procedure

The uncorrelated jitter measurement is performed using the algorithm library.

Inputs to algorithm

- · Differential waveform obtained on a Math channel using Data+ and Data- after deskewing
- Signal Type ("SFPPlus.SignalType")

Algorithm

- · Input differential waveform.
- Identify the deviation of each rising and falling edge on the input signal from its ideal location (constructed using UI = 1÷ data rate) (Note: consider the rising and falling edges of a pattern with the longest run of 1s to maintain some uniformity on the edges to measure deviations. If the deviations were measured on all edges, then the deviations are inconsistent for different edges resulting in measurement errors.)
- Find the standard deviation of the deviations of the rising edges. Find the standard deviation of the deviation of the falling edges.
- Compute UJ as follows:

Uncorellated jitter (rms) =
$$\sqrt{(\sigma_r^2 + \sigma_f^2)/2}$$

where σr is the standard deviation of the jitter on the rising edge

where σf is the standard deviation of the jitter on the falling edge

End

Output from algorithm

m_SFPPlusISDB.Result1Mean.Value = UJ.Mean

Maximum value = 0.023 UI

Snapshot and cursor placement details

No cursors are required. Uncorrelated jitter cannot be shown using cursors or snapshots. Zoom a part of the waveform to see the type of waveform used for the measurement. Zoom the waveform between time 0 and (horizontal scale \div 10⁴). If the record length is 2M, the number of points in the zoomed part will be 200.

Transmitter Qsq

Transmitter Qsq is measured on the differential data signal as the inverse of Relative Noise (RN). This test is one of the SFF-8431 Table 12 Jitter and Eye Mask Specifications at B tests.

Connect the equipment as shown in the diagram at Connection Setup for Host Tests: All other tests.

Signal validation

For compliance, perform Signal Validation Procedure.

Measurement procedure

The transmitter Qsq measurement is performed using the algorithm library.

Inputs to algorithm

- · Differential waveform obtained on a Math channel using Data+ and Data- after deskewing
- Signal Type ("SFPPlus.SignalType");
- Window Width ("SFPPlus.QsqWidth");

Algorithm

- · Input differential PRBS waveform
- Compute VMA as given by the VMA algorithm. On the input waveform, identify the regions with the pattern 11111111 or 00000000.
- On each such pattern, measure the AC RMS voltage in the 10% window where the waveform is the flattest.
- The AC RMS in the 11111111 regions is LevelONENoise, and that in 00000000 regions is

$$\sqrt{(levelONEnoise^2 + LevelZEROnoise^2)/2}$$

LevelZERONoise. Noise (rms) is measured as:

$$RN = \frac{2 * Noise(rms)}{VMA}$$

- Measure Relative Noise as:
 - The required result Tx Qsq is given by Tx Qsq = 1 ÷ RN

• End

Output from algorithm

m_SFPPlusISDB.Result1Mean.Value = TxQsq.Mean	
m_SFPPlusISDB. Hist1Left.Value = LevelONEnoise window begin	
m_SFPPlusISDB. Hist1Right.Value = LevelONEnoise window end	
m_SFPPlusISDB.HorizontalPos1.Value = position of the waveform where to zoom for LevelONEnoise	
Table continued	

m_SFPPlusISDB.HorizontalScale1.Value = scale of Zoom that is to be set for LevelONEnoise
m_SFPPlusISDB. Hist2Left.Value = LevelZEROnoise window begin
m_SFPPlusISDB. Hist2Right.Value = LevelZEROnoise window end
m_SFPPlusISDB.HorizontalPos2.Value = position of the waveform where to zoom for LevelZEROnoise
m_SFPPlusISDB.HorizontalScale2.Value = scale of Zoom that is to be set for LevelZEROnoise

Minimum value = 50

Snapshot and cursor placement details

This measurement has two snapshots with zoom showing one full period of the 8180 pattern. The first snapshot has cursor1 and cursor2 marking the flattest region of the high part of the period. The second snapshot has cursor1 and cursor2 marking the flattest region of the low part of the period.

Eye mask hit ratio (Host)

The required transmitter pulse shape characteristics are specified in the form of a mask of the transmitter eye diagram (used to measure the number of Mask Hits). Eye mask hit ratio is computed using eye mask hit ratio = (Number of Mask Hits × Signaling Speed) ÷ (Number of Uls × Sampling rate). This test is one of the SFF-8431 Table 12 Jitter and Eye Mask Specifications at B tests.

Connect the equipment as shown in the diagram at Connection Setup for Host Tests: All other tests.

Signal validation

Signal validation for PRBS31 pattern signals is not done by the SFP+ QSFP+ Tx application. The software assumes that the PRBS31 pattern is valid.

Measurement procedure

Eye mask hit ratio is measured using base DPOJET.

- Deskew the Data+ and Data- inputs. Compute the differential signal on Math1 = Dp Dn.
- Use DPOJET Mask Hits measurement on the Math signal and Skew measurement on the single-ended input signals.

DPOJET settings

- Select Tab: Select Eye >Mask Hits.
 - Configure the Source:
 - Click the arrow button in the Source(s) column and configure Source 1 = Math 1 (Dp–Dn)
 - Select the Advanced check box and then set Reference Level % relative to Base Top as follows:

Setting	Rise	Fall
High	80%	80%
Mid	50%	50%
Low	20%	20%
Hysteresis	5%	

- Click Close
- Configure Tab:
 - Edges: Signal Type = Data
 - Clock Recovery:

- Method = PLL Custom BW
- PLL Model = Type II
- Damping = 700 m
- Loop BW = 4 MHz
- Click the Advanced button:
 - Nominal Data Rate = ON. Bit Rate = 10.3125 Gb/s
 - Known Data Pattern = OFF
 - Click OK.
- Click Apply.
- RjDJ:

For PRBS9 signal:

- Pattern Type = Repeating
- Pattern Length = 511 UI
- BER 1E- = 12

For PRBS31 signal:

- Pattern Type = Arbitrary
- Window length = 10 UI
- Population = 100
- BER 1E- = 12
- Filters: No filters
- General: OFF
- Global:
 - Gating = OFF
 - Quality = **OFF**
 - Population = OFF
- Click Run.



Note: Run until population crosses 2M.

The Mask Hits DPOJET measurement gives the number of Mask hits. Plug that value into the following formula to obtain the Mask Hit Ratio:

Mask Hit Ratio = Number of Mask Hits × Signaling Speed (10.3125 e^9) ÷ Number of UIs (Population from DPOJET) × Sampling Rate (50 e^9)

Limits

Mask hit ratio of 5 x 10⁻⁵

Snapshot and cursor placement details

This measurement has one snapshot of the eye mask hit generated in DPOJET. No cursors are required.

Host test: SFF-8431 table 33 tests

Voltage modulation amplitude (p-p)

Voltage modulation amplitude is measured as the difference between the nominal one and zero levels, which are defined as voltages measured in the mid 20% of the high (eight 1s) and low (eight 0s) regions respectively, of the differential data signal. This test is one of the SFF-8431 Table 33 Output Specifications at B for Cu tests.

Connect the equipment as shown in the diagram Connection Setup for Host Tests: All other Host tests.

Signal validation

For compliance, perform Signal Validation Procedure.

Measurement procedure

The voltage modulation amplitude (p-p) measurement is performed using the algorithm library.

Inputs to algorithm

- · Differential waveform obtained on a Math channel using Data+ and Data- after deskewing
- Signal Type ("SFPPlus.SignalType")

Algorithm

- Input differential PRBS waveform.
- On the input waveform identify the regions with the pattern 11111111 or 00000000.
- On each such pattern measure the mean voltage in the middle 20% of the pattern.
- The mean voltages corresponding to the Signal High regions is taken as vHigh and the mean voltages corresponding to the Signal Low
 is taken as vLow. The vHigh and vLow values are averaged across all regions.
- The required result VMA is given by, VMA = vHigh vLow
- End

Limits

Minimum value = 300 mV

Snapshot and cursor placement details

This measurement has one snapshot with cursor1 = +ve high of VMA, cursor2 = -ve high of VMA.

Transmitter Qsq (for Cu)

Transmitter Qsq is measured on the differential data signal as the inverse of Relative Noise (RN). RN is measured as RN = $2 \times \text{Noise}$ (rms) $\div \text{VMA}$. And Noise(rms) = Sq rt ((LogicONENoise(rms)2 + LogicZERONoise(rms)2) $\div 2$). This test is one of the SFF-8431 Table 33 Output Specifications at B for Cu tests.

Connect the equipment as shown in the diagram Connection Setup for Host Tests: All other Host tests.

Signal validation

For compliance, perform Signal Validation Procedure.

Measurement procedure

The transmitter Qsq (for Cu) measurement is performed using the algorithm library.

Inputs to algorithm

- · Differential waveform obtained on a Math channel using Data+ and Data- after deskewing
- Signal Type ("SFPPlus.SignalType");

Algorithm

- Input differential PRBS waveform
- Compute VMA as given by the VMA algorithm. On the input waveform, identify the regions with the pattern 11111111 or 00000000.
- On each such pattern, measure the AC RMS voltage in the 10% window where the waveform is the flattest.
- The AC RMS in the 11111111 regions is LevelONENoise, and that in 00000000 regions is

 $\sqrt{(levelONEnoise^2 + LevelZEROnoise^2)/2}$

LevelZERONoise. Measure Noise (rms) as:

$$RN = \frac{2 * Noise(rms)}{VMA}$$

Measure Relative Noise as:

The required result TxQsq is given by TxQsq = 1 ÷ RN

End

Output from algorithm

m_SFPPlusISDB.Result1Mean.Value = TxQsq.Mean

Limits

Minimum value = 63.1

Snapshot and cursor placement details

This measurement has two snapshots with zoom showing one full period of the 8180 pattern. The first snapshot has cursor1 and cursor2 marking the flattest region of the high part of the period. The second snapshot has cursor1 and cursor2 marking the flattest region of the low part of the period.

Output AC Common-Mode voltage (RMS) (for Cu)

Output AC common-mode voltage is measured as the AC RMS voltage of the common-mode ((DP + DN) ÷ 2) signal. This test is one of the SFF-8431 Table 33 Output Specifications at B for Cu tests.

Connect the equipment as shown in the diagram at Connection Setup for Host Tests: All other Host tests.

Signal validation

Signal validation for PRBS31 pattern signals is not done by the SFP+ QSFP+ Tx application. The software assumes that the PRBS31 pattern is valid.

Measurement procedure

The output AC common-mode voltage (RMS) (for Cu) measurement is performed using the base oscilloscope.

- 1. Math1 = $(Dp + Dn) \div 2$. Switch off channels connected to Dp and Dn.
- 2. Draw a histogram bounding box from top left of the oscilloscope to the bottom right and choose Histogram Vertical.
- 3. Select Math1 as the histogram source.
- 4. From the Measurement menu, select Histogram Measurements > Standard Deviation.
- 5. Do a single step run and measure the mean value of the histogram standard deviation. This is the measurement result.

Limits

Maximum = 12 mV

Snapshot and cursor placement details

A screen shot where the histogram on math and the standard deviation value of the histogram is visible on the screen. The visible standard deviation value should be the value shown in the report. No cursors are required.

Host output TWDPc



Note: The Host Output TWDPc test is supported only on oscilloscopes that support 100 Gs/s. For details, see Compatibility.

TWDP is a measure of the deterministic dispersion penalty due to a particular transmitter with reference emulated multi-mode fibers and receiver. TWDP is initially defined to characterize the performance of a transmitter in optical links. The same concept has been extended to quantify channel performance, especially in high-speed copper links.

This test is one of the SFF-8431 Revision 4.1 Table 33-Host Transmitter Output Specifications at B for Cu tests.

Note: The TWDPc measurement is supported only on a Ch1–Ch3 combination setup of a C or D series oscilloscope. 100 GS/s RT mode output on Ch2 and Ch4 is not available. Therefore, if Ch1 is not working, the test cannot be performed successfully.

Connect the equipment as shown in the diagram at Connection Setup for Host Tests: All other Host tests.

Signal validation

For compliance, perform Signal Validation Procedure.

Measurement procedure

The Host output TWDPc measurement is performed using the algorithm library.

Inputs to algorithm

- Differential waveform obtained on a Math channel using Data+ and Data- after deskewing. Sampled at 3.3 TS/s using IT mode.
- Signal Type ("SFPPlus.SignalType");

Algorithm

- Input the differential waveform (sampled at 3.3 TS/s IT)
- · Down sample the differential input waveform to 16 samples per UI (which is down sampling 20 times)
- Identify all the PRBS9 patterns in the waveform. For each PRBS9 pattern, write all points to a text file and call the SFF8431 x WDP algorithm.
- The required result TWDPc is the average value of the TWDP calculated for each PRBS9 pattern.
- End

Output from algorithm

m_SFFPlusISDB.Result1Mean.Value = Average TWDPc value

Limits

Maximum value = 10.7 dBe

Module test: SFF-8431 table 16 tests

AC Common-Mode voltage tolerance (Module)

Output AC common-mode voltage tolerance is measured as the AC RMS voltage of the common mode ((DP+DN)÷2) signal. This is one of the SFF-8431 Revision 4.1 Table 16 Module Transmitter Input Electrical Specifications at B' tests.

Connect the equipment as shown in the diagram at Connection Setup for Module Tests: All other Module tests.

Signal validation

Automatic signal validation for PRBS31 pattern signals is not done by the SFP+ QSFP+ Tx application. The software assumes that the PRBS31 pattern is valid.

Measurement procedure

AC common-mode voltage tolerance is measured using the base oscilloscope.

- 1. Generate the AC common-mode waveform on Math1 = (Dp + Dn) ÷ 2. Switch off the channels connected to Dp and Dn.
- 2. Add the base oscilloscope measurement Min and Max. Choose Math1 as the source in both cases.
- 3. Perform a single run and read theMin andMax values.

Limits

Min (Abs(Min), Abs(Max)) > 15 V (Table 16)

Snapshot and cursor placement details

A snapshot of the common-mode voltage is displayed on the oscilloscope.

Single-Ended input voltage tolerance (Module)

Single-ended input voltage tolerance is measured as the single-ended peak-to-peak input voltage for the positive and negative data channels on a single acquisition. This test is one of the SFF-8431 Revision 4.1 Table 16 Module Transmitter Input Electrical Specifications at B' tests.

Connect the equipment as shown in the diagram at Connection Setup for Module Tests: Single-Ended Input Voltage Tolerance Test.

Signal validation

Automatic signal validation for PRBS31 pattern signals is not done by the SFP+ QSFP+ Tx application. The software assumes that the PRBS31 pattern is valid.

Measurement procedure

Single-ended input voltage tolerance is measured using base DPOJET.

- Use DPOJET measurement name: Ampl > Cycle Pk-Pk
- Use DPOJET settings: All default settings

Limits

For each of Dp and Dn:

- Minimum = -0.3 V
- Maximum = 4 V

Snapshot and cursor placement details

There will be two snapshots:

- A snapshot of Dp with cursors placed at maximum and minimum voltages of single-ended Pk-Pk measurement value of Dp. Cursor values can be derived using DPOJET: Ampl > Cycle Max and Ampl > Cycle Min for +ve and –ve peak, respectively for Dp.
- A snapshot of Dn with cursors placed at maximum and minimum voltages of single-ended Pk-Pk measurement value of Dn. Cursor values can be derived using DPOJET: **Ampl > Cycle Max** and **Ampl > Cycle Min** for +ve and –ve peak, respectively for Dn.

Module test: SFF-8431 table 17 tests

Crosstalk source Rise/Fall time (20% - 80%) (Module)

Crosstalk source rise/fall time is measured as the 20% – 80% (of VMA) Rise time and 80% – 20% (of VMA) Fall time of the differential crosstalk source introduced to the signal. This test is one of the SFF-8431 Table 17 Module Transmitter Input Tolerance Signal Calibrated at B" tests.

Connect the equipment as shown in the diagram at Connection Setup for Module Tests: All other Module tests.

Signal validation

For compliance, perform Signal Validation Procedure.

Measurement procedure

The crosstalk source rise/fall time (20% - 80%) measurement is performed using the algorithm library.

Inputs to algorithm

- Differential waveform obtained on a Math channel using Dp and Dn after deskewing and applying 12 GHz filter
- Signal Type ("SFPPlus.SignalType")

Algorithm

- Input differential waveform.
- Obtain values of vHigh and vLow as done in the VMA measurement (averaged over all the patterns found in the waveform).
- · Find the position of rising and falling edges in the input waveform.
- On each rising edge, traverse forward until the first point crossing the upper limit (80%) is found (= End) and traverse backward until the first point crossing the lower limit (20%) is found (= Start).
- On each falling edge, traverse backward until the first point crossing the upper limit (80%) is found (= Start) and traverse forward until the first point crossing the lower limit (20%) is found (= End).
- Transition time is computed as TT = (End Start). This value is averaged across all edges.
- End

Limits

Target value = 34 ps

Snapshot and cursor placement details

This measurement has two snapshots: the first with cursors placed at the rise time, the second with cursors placed at the fall time.

- Rise time: Zoom to the cursor positions. Cursor1 = starting point of RT of first rising edge, cursor2 = ending point of RT of first rising edge.
- Fall time: Zoom to the cursor positions. Cursor1 = starting point of FT of first falling edge, cursor2 = ending point of FT of first falling edge.

Cursor values and zoom positions are provided by the Algorithm library.

Crosstalk source amplitude (p-p differential) (Module)

Crosstalk source amplitude is measured as the difference between the nominal one and zero levels, which are defined as voltages measured in the mid 20% of the high (eight 1s) and low (eight 0s) regions respectively, of the differential crosstalk source introduced to the signal. This is one of the SFF-8431 Revision 4.1 Table 17 Module Transmitter Input Tolerance Signal Calibrated at B" tests.

Connect the equipment as shown in the diagram at Connection Setup for Module Tests: All other Module tests.

Signal validation

For compliance, perform Signal Validation Procedure.

Measurement procedure

The crosstalk source amplitude (p-p differential) measurement is performed using the algorithm library.

Inputs to algorithm

Differential waveform obtained on a Math channel using Dp and Dn after deskewing and applying 12 GHz filter

Algorithm

- · Input differential PRBS waveform.
- On the input waveform, identify the regions with the pattern 11111111 or 00000000.
- On each such pattern, measure the mean voltage in the middle 20% of the pattern.
- The mean voltages corresponding to the Signal High regions is taken as vHigh, and the mean voltages corresponding to the Signal Low is taken as vLow. The vHigh and vLow values are averaged across all regions.
- The required result amplitude is given by, Amplitude = vHigh vLow.
- End

Limits

Target value = 1000 mV

Snapshot and cursor placement details

This measurement has one snapshot with cursor1 = +ve high of VMA, cursor2 = -ve high of VMA.

Output AC Common-Mode voltage (RMS) (Module)

Output AC common-mode voltage is measured as the AC RMS voltage of the common-mode ((DP + DN)÷2) signal. This test is one of the SFF-8431 Revision 4.1 Table 17 Module Transmitter Input Tolerance Signal Calibrated at B" tests.

Connect the equipment as shown in the diagram at Connection Setup for Module Tests: All other Module tests.

Signal validation

Signal validation for PRBS31 pattern signals is not done by the SFP+ QSFP+ Tx application. The software assumes that the PRBS31 pattern is valid.

Measurement procedure

Output AC common-mode voltage (RMS) is measured using the base oscilloscope.

- 1. Math1 = (Dp + Dn) ÷ 2. Switch off channels connected to Dp and Dn.
- 2. Draw a histogram bounding box from the top left of the oscilloscope to the bottom right, and choose Histogram Vertical.
- 3. Select Math1 as the histogram source.
- 4. From the Measure menu, select Histogram Measurements > Standard Deviation.
- 5. Do a single step run and measure the mean value of the histogram standard deviation. This is the measurement result.

Limits

Maximum = 15 mV (Table 17)

Snapshot and cursor placement details

A snapshot where the histogram on math and the standard deviation value of the histogram is visible on the screen. The standard deviation value visible on the screen should be the value reported in the report. No cursors are required.

Total jitter (Module)

Total jitter, as used here, is the Level 1 definition for TJ as described in the FC-MJSQ, where TJ is the crossing width, defined as the late time at which the BER is 10–12 minus the early time at which the BER is 10–12. This test is one of the SFF-8431 Revision 4.1 Table 17 Module Transmitter Input Tolerance Signal Calibrated at B" tests.

Connect the equipment as shown in the diagram at Connection Setup for Module Tests: All other Module tests.

Signal validation

Signal validation for PRBS31 pattern signals is not done by the SFP+ QSFP+ Tx application. The software assumes that the PRBS31 pattern is valid.

Measurement procedure

Total jitter is measured using base DPOJET.

- Deskew the Data+ and Data- inputs. Compute the differential signal on Math1 = Dp Dn.
- Use DPOJET TJ@BER measurement on the Math signal and Skew measurement on the single ended input signals.

DPOJET settings

- Select Tab: Select Jitter, click TJ@BER.
 - Configure the source:
 - Click the arrow button in the Source(s) column and configure Source 1 = Math 1 (Dp Dn)
 - Select the Advanced check box and then set Reference Level % relative to Base Top as follows:

Setting	Rise	Fall
High	80%	80%
Mid	50%	50%
Low	20%	20%
Hysteresis	5%	

- Click Close.
- Configure Tab:
 - Edges: Signal Type = Data
 - Clock Recovery:
 - Method = PLL-Custom BW
 - PLL Model = Type II
 - Damping = **700 m**
 - Loop BW = 4 MHz
 - Click the Advanced Button:
 - Nominal Data Rate = ON. Bit Rate = 10.3125 Gb/s
 - Known Data Pattern = OFF

- Click OK.
- RjDj:

For PRBS9 signal:

- Pattern Type = Repeating
- Window length = 511 UI
- BER 1E- = 12 (for J2 BER 1E- = 2.6; for J9 BER 1E- = 9.6)

For PRBS31 signal:

- Pattern Type = Arbitrary
- Window length = 10 UI
- Population = 100
- BER 1E- = 12 (for J2 BER 1E- = 2.6; for J9 BER 1E- = 9.6)
- Filters: No filters
- General: OFF
- Global:
 - Gating: OFF
 - Quality: OFF
 - Population: OFF
- Results Tab: In the Options menu, deselect Display Units Absolute.
- Click Single.

Limits

Maximum value = 0.28 UI

Snapshot and cursor placement details

No cursors are required because total jitter cannot be shown using cursors or snapshots. Instead, zoom a part of the waveform to see the type of waveform used for the measurement. Zoom the waveform between time 0 and (Horizontal scale \div 10⁴). If the record length is 2M, the number of points in the zoomed part will be 200.

Data dependent jitter (Module)

DDJ is the range (max – min) of the timing variations measured on the differential signal with a crossing level equal to the average value of the entire waveform being measured. The waveform is averaged sufficiently to remove the effects of random jitter and noise in the system. This test is one of the SFF-8431 Revision 4.1 Table 17 Module Transmitter Input Tolerance Signal Calibrated at B" tests.

Connect the equipment as shown in the diagram at Connection Setup for Module Tests: All other Module tests.

Signal validation

For compliance, perform Signal Validation Procedure.

Measurement procedure

Data dependent jitter is measured using base DPOJET.

- Deskew the Data+ and Data- inputs. Compute the differential signal on Math1 = Dp Dn
- · Use DPOJET DDJ measurement on the Math signal and Skew measurement on the single ended input signals.

DPOJET settings

• Select Tab: select Jitter, click DDJ.

- Source configuration:
 - Source = Math 1 (Ch1 Ch1)
 - Select the Advanced check box and then set Reference Level % relative to Base Top as follows:

Setting	Rise	Fall
High	80%	80%
Mid	50%	50%
Low	20%	20%
Hysteresis	5%	

- Click Close.
- Configure Tab:
 - Clock Recovery:
 - Method = PLL-Custom BW
 - PLL Model = Type II
 - Damping = 700 m
 - Loop BW = 4 MHz
 - Click the Advanced Button:
 - Nominal Data Rate = ON. Bit Rate = 10.3125 Gb/s
 - Known Data Pattern = **OFF**
 - Click OK.
 - RjDj:

For PRBS9:

- Pattern Type = Repeating
- Window length = 511 UI
- BER 1E- = 12

For PRBS31:

- Pattern Type = Arbitrary
- Window length = 10 UI
- Population = 100
- BER 1E- = 12
- Filters: No filters
- General: OFF
- · Global:
 - Gating: OFF
 - Quality: **OFF**
 - Population: OFF
- Results Tab: In the Options menu, deselect Display Units Absolute.
- Click Single.

Limits

Target value = 0.10 UI

Snapshot and cursor placement details

No cursors are required because Data Dependent Jitter cannot be shown using cursors or snapshots. Instead, zoom a part of the waveform to see the type of waveform used for the measurement. Zoom the waveform between time 0 and (Horizontal scale \div 10⁴). If the record length is 2M, the number of points in the zoomed part will be 200.

Data dependent pulse width shrinkage (Module)

DDPWS is measured as the difference between one symbol period and the minimum of all the differences between pairs of adjacent edges on the Differential Signal with a crossing level equal to the average value of the entire waveform being measured. The waveform is averaged sufficiently to remove the effects of random jitter and noise in the system. This is a SFF-8431 Revision 4.1 Table 17 Module Transmitter Input Tolerance Signal Calibrated at B" test.

Connect the equipment as shown in the diagram at Connection Setup for Module Tests: All other Module tests.

Signal validation

For compliance, perform Signal Validation Procedure.

Measurement procedure

The data dependent pulse width shrinkage measurement is performed using the algorithm library.

Inputs to algorithm

Differential waveform obtained on a Math channel using Data+ and Data- after deskewing.

Algorithm

- Input differential waveform.
- Estimate the UI of the waveform (UI = bit duration).
- · Identify all the PRBS9 patterns found in the acquired signal.
- Overlap all the PRBS9 patterns found in the acquisition to get a single averaged PRBS9 pattern.
- Identify the minimum width between adjacent edges of the averaged PRBS9 pattern. [= minimum UI]
- Compute Data Dependent Pulse Width Shrinkage (DDPWS) as: DDPWS = Estimated UI minimum UI.

Limits

Target value = 0.055 UI

Snapshot and cursor placement details

This measurement has one zoomed snapshot with cursor1 and cursor2 marking the smallest UI.

Uncorrelated jitter (Module)

Uncorrelated jitter refers to the component of jitter in the transmitted signal that is not correlated to the transmitter data. The uncorrelated jitter (rms) is given by the RMS value of the standard deviations of the two distributions, namely standard deviation of jitter on rising edge and standard deviation of jitter on falling edge. This test is one of the SFF-8431 Table 17 Module Transmitter Input Tolerance Signal Calibrated at B" tests.

Connect the equipment as shown in the diagram at Connection Setup for Module Tests: All other Module tests.

Signal validation

For compliance, perform Signal Validation Procedure.

Measurement procedure

The uncorrelated jitter measurement is performed using the algorithm library.

Inputs to algorithm

- · Differential waveform obtained on a Math channel using Data+ and Data- after deskewing
- Signal Type ("SFPPlus.SignalType")

Algorithm

- Input differential waveform.
- Identify the deviation of each rising and falling edge on the input signal from its ideal location (constructed using UI = 1÷ data rate) (Note: consider the rising and falling edges of a pattern with the longest run of 1s to maintain some uniformity on the edges to measure deviations. If the deviations were measured on all edges, then the deviations are inconsistent for different edges resulting in measurement errors.)
- Find the standard deviation of the deviations of the rising edges. Find the standard deviation of the deviation of the falling edges.
- · Compute UJ as follows:

Uncorellated jitter (rms) =
$$\sqrt{(\sigma_r^2 + \sigma_f^2)/2}$$

where σr is the standard deviation of the jitter on the rising edge

where of is the standard deviation of the jitter on the falling edge

End

Output from algorithm

m_SFPPlusISDB.Result1Mean.Value = UJ.Mean

Limits

Target value = 0.023 UI

Snapshot and cursor placement details

No cursors are required. Uncorrelated jitter cannot be shown using cursors or snapshots. Zoom a part of the waveform to see the type of waveform used for the measurement. Zoom the waveform between time 0 and (H-scale \div 10⁴). If the record length is 2M, the number of points in the zoomed part will be 200.

Eye mask hit ratio (Module)

The required transmitter pulse shape characteristics are specified in the form of a mask of the transmitter eye diagram (used to measure the number of Mask Hits). Eye Mask hit ratio is computed using Eye Mask hit ratio = (Number of Mask Hits × Signaling Speed) ÷ (Number of UIs × Sampling rate). This test is one of the SFF-8431 Revision 4.1 Table 17 Module Transmitter Input Tolerance Signal Calibrated at B" tests.

Connect the equipment as shown in the diagram at Connection Setup for Module Tests: All other Module tests.

Signal validation

Automatic signal validation for PRBS31 pattern signals is not done by the SFP+ QSFP+ Tx application. The software assumes that the PRBS31 pattern is valid.

Measurement procedure

Eye mask hit ratio is measured using base DPOJET.

• Deskew the Data+ and Data- inputs. Compute the differential signal on Math1 = Dp - Dn.

• Use DPOJET Mask Hits measurement on the Math signal and Skew measurement on the single-ended input signals.

DPOJET settings

- Select Tab: Select Eye, click Mask Hits.
 - Configure the source:
 - Click the arrow button in the Source(s) column and configure Source 1 = Math 1 (Dp Dn)
 - Select the Advanced check box and then set Reference Level % relative to Base Top as follows:

Setting	Rise	Fall
High	80%	80%
Mid	50%	50%
Low	20%	20%
Hysteresis	5%	

- Click Close.
- Configure Tab:
 - Edges: Signal Type = Data
 - Clock Recovery:
 - Method = PLL Custom BW
 - PLL Model = Type II
 - Damping = 700 m
 - Loop BW = 4 MHz
 - Click the Advanced Button:
 - Nominal Data Rate = ON. Bit Rate = 10.3125 Gb/s
 - Known Data Pattern = OFF
 - Click OK.
 - Click Apply.
 - RjDj:

For PRBS9 signal:

- Pattern Type = Repeating
- Pattern length = 511 UI
- BER 1E- = 12

For PRBS31 signal:

- Pattern Type = Arbitrary
- Window length = 10 UI
- Population = 100
- BER 1E– = **12**
- Filters: No filters
- General: OFF
- Global:
 - Gating: OFF
 - Quality: OFF

• Population: OFF

Click Run.

Note: Run until population crosses 2M.

The Mask Hits DPOJET measurement gives the number of Mask hits. Plug that value into the following formula to obtain the Mask hit ratio:

Mask Hit Ratio = Number of Mask Hits × Signaling Speed (10.3125 e^9) ÷ Number of UIs (Population from DPOJET) × Sampling Rate (50 e^9)

Limits

Mask hit ratio of 5 x 10⁻⁵

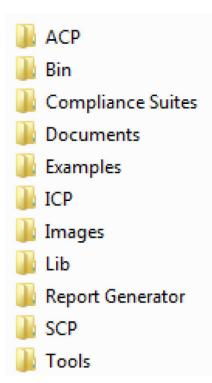
Snapshot and cursor placement details

This measurement has one snapshot of the eye mask hit generated in DPOJET. No cursors are required.

References

Application directories

You can find the application files at C:\Program Files\Tektronix\TekExpress SFP+ QSFP+. The application directory and associated files are organized as follows:



The following table lists the default directory names and their usage:

Table 22: Application directories and usage

Directory names	Usage
ACP	Contains instrument and application specific interface libraries
Bin	Contains application libraries
Compliance Suites	Contains test suite specific files
Documents	Contains the technical documents of the application.
Examples	Contains various support files
ICP	Contains instrument and application specific interface libraries
Images	Contains images of the application
Lib	Contains utility files specific to the application
Licenses	Contains all the license files
Report Generator	Contains style sheets for report generation
SCP	Contains instrument and application specific interface libraries
Tools	Contains instrument and application specific files

File name extensions

The TekExpress SFP+ QSFP+ software uses the following file name extensions:

Table 23: File name extension

File name extension	Description
*.TekX	Application session files (the extensions may not be displayed)
*.ру	Python sequence file.
*.xml	Test-specific configuration information (encrypted) files. Application log files
*.CSV	Test result reports Plot data
*.mht	Test result reports (default) Test reports can also be saved in HTML format
*.pdf	Test result reports Application help document
*.xslt	Style sheet used to generate reports
*.png	Captured images
.wfm	Test waveform file

View test-related files

Files related to tests are stored in My Documents\TekExpress SFP+ QSFP+\Untitled session folder. Each test setup in this folder has both a test setup file and a test setup folder, both with the test setup name. The test setup file is preceded by the TekExpress icon.

Inside the test setup folder is another folder named for the DUT ID used in the test sessions. The default is DUT001.

Inside the DUT001 folder are the session folders and files. Each session also has a folder and file pair, both named for the test session using the naming convention (date)_(time). Each session file is stored outside its matching session folder:

20110520_154553
20110520_154713
20110520_155111
20110520_155920
20110520_160103
🞺 20110520_154553
🞺 20110520_154713
🞺 20110520_155111
🞺 20110520_155920
VV 20110520_160103

Each session folder contains image files of any plots generated from running the test session. If you selected to save all waveforms or ran tests using prerecorded waveform files, these are included here.

The first time you run a new, unsaved session, the session files are stored in the Untitled Session folder located at X:\TekExpress SFP+ QSFP+. When you name and save the session, the files are placed in a folder with the name that you specify. A copy of the test files stay in the Untitled Session folder until you run a new test or until you close the application.

De-embed using filter files

TekExpress SFP+ QSFP+ Tx provides an option to de-embed the signal path using filter files. You create the filter files. The filter files are .flt files composed of de-embed filter coefficients for a particular sampling rate. A filter file created for one sampling rate might not work for other sampling rates, so it is important to understand at what sampling rate the measurements are being performed. The following table summarizes the sampling rates used for each measurement.

Table 24: Measuremen	t sampling	rates
----------------------	------------	-------

Measurement	Oscilloscope model	
	DPO/DSA/MSO C, D, DX, and SX Series (>16 GHz BW)	
	Input on Ch1 and Ch3	
Single-Ended Output Voltage Range	100 GS/s	
Output AC Common Mode Voltage (RMS)		
Host Transmitter Jitter and Eye Mask specifications		
Crosstalk Source Rise/Fall Time (20% – 80%)	100 GS/s	
Crosstalk Source Amplitude (p-p differential)		
Signal Rise/Fall Time (20% – 80%)		
Total Jitter (p–p)		
Data Dependent Jitter (p–p)		
Data Dependent Pulse Width Shrinkage (p-p)		
Uncorrelated Jitter (RMS)		
Transmitter Qsa		
Eye Mask Hit Ratio		
Host Transmitter Output Specifications for CU (SFP+ Host supporting direct attached cables)		
Voltage Modulation Amplitude (p-p)	100 GS/s	
Transmitter Qsa		
Output AC Common Mode Voltage		
Host Output TWDPc	3.3 TS/s	

Deskew channels

If skew is present between positive and negative channels, then the channels need to be deskewed before being used for waveform measurements. TekExpress SFP+ QSFP+ Tx provides support for channel deskew using the following method:

- 1. Determine what the skew is for each channel.
- 2. From the TekScope menu, select Vertical > Deskew.
- 3. In the Deskew/Attenuation window, click the channel (1 4) button for the first channel to be deskewed.
- 4. Click in the Ch(x) Deskew Time entry field and enter the skew. The skew can be +ve or -ve.
- 5. Click the channel button for the next channel and repeat step 4.
- 6. After entering the skew for all the channels that require it, from the Options menu in TekExpress SFP+ QSFP+ Tx, select Deskew.

- 7. In the Deskew dialog box, select the desired level:
 - Less than 100 mV signal amplitude: Select this if the signal amplitude is such that the oscilloscope's vertical setting is less than 100 mV/division.
 - 100 mV or greater signal amplitude: Select this if the signal amplitude is such that the oscilloscope's vertical setting is greater than 100 mV/division.
- 8. Click Read Deskew/Attn.
- 9. When the status in the dialog box indicates the deskew is finished, click Close.

Each input channel has its own deskew settings. Deskew compensates individual channels for probes or cables of different lengths. The instrument applies the delay values after each completed acquisition. The deskew values are saved as part of the instrument setup. The deskew values for the selected channel are retained until you change the probe, you restore a saved setup, or you recall the factory setup.

Map the My TekExpress folder

Follow these steps to map the My TekExpress folder on the instrument:

- **1.** Open Windows Explorer.
- 2. From the Windows Explorer menu, click Computer.
- 3. In the menu bar, select Map network drive.
- 4. Select the Drive letter as X: (if there is any previous connection on X:, disconnect it first through Tools > Disconnect Network drive menu of Windows Explorer. Windows 7 users: if you do not see the Tools menu, press the Alt key).
- 5. In the Folder field, enter the remote My TekExpress folder path (for example, \\192.158.97.65\ My TekExpress).

To determine the IP address of the instrument where the My TekExpress folder exists, do the following:

- 1. On the instrument where the My TekExpress folder exists, click Start and select Run.
- 2. Type "cmd" and then press Enter.
- 3. At the command prompt, type "ipconfig" and then press Enter.

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